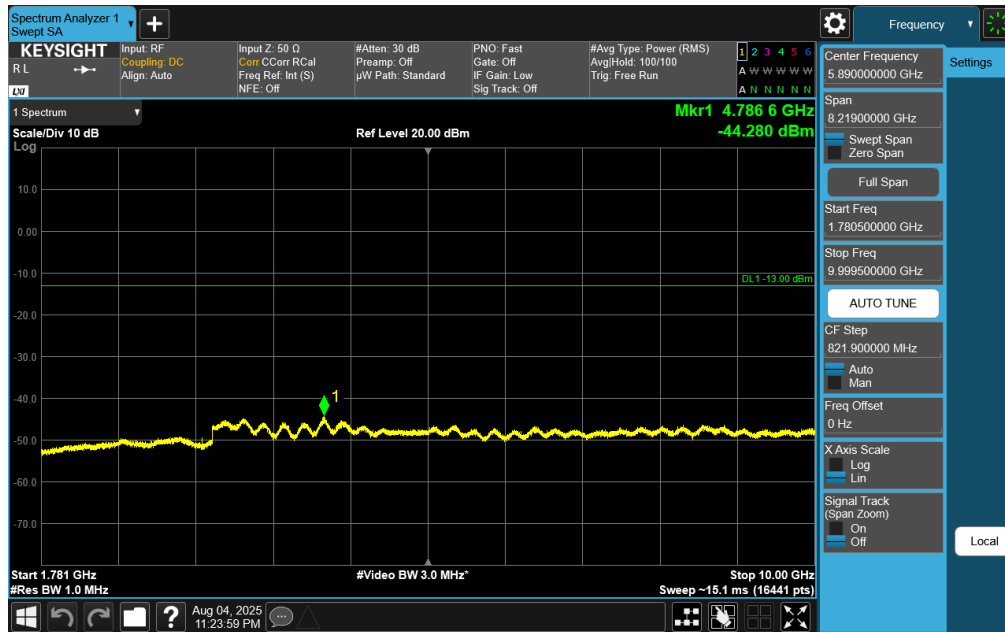
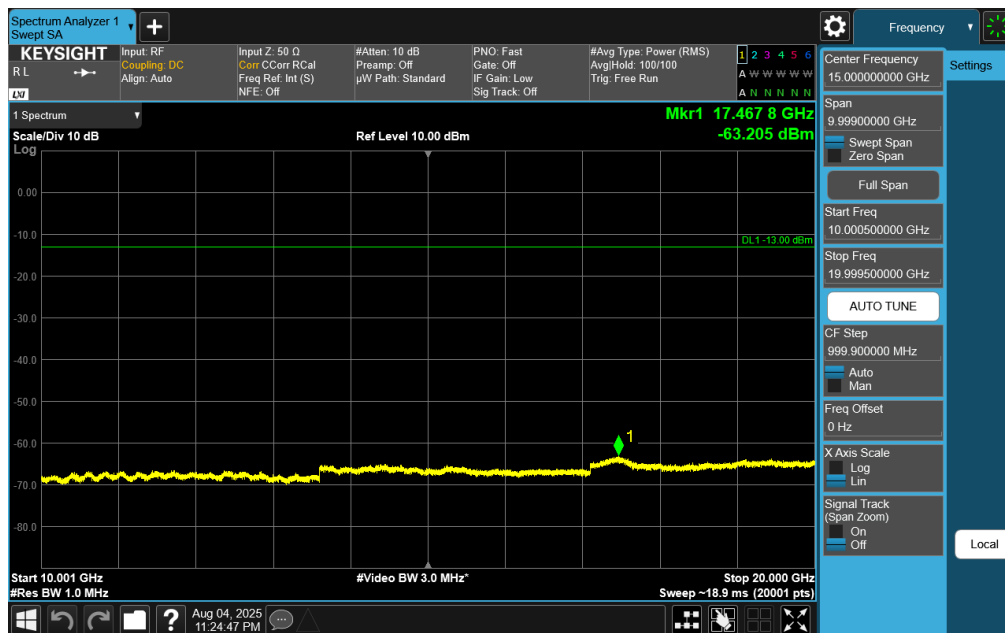




Plot 7-200. Conducted Spurious Plot (NR Band n66 - 45.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

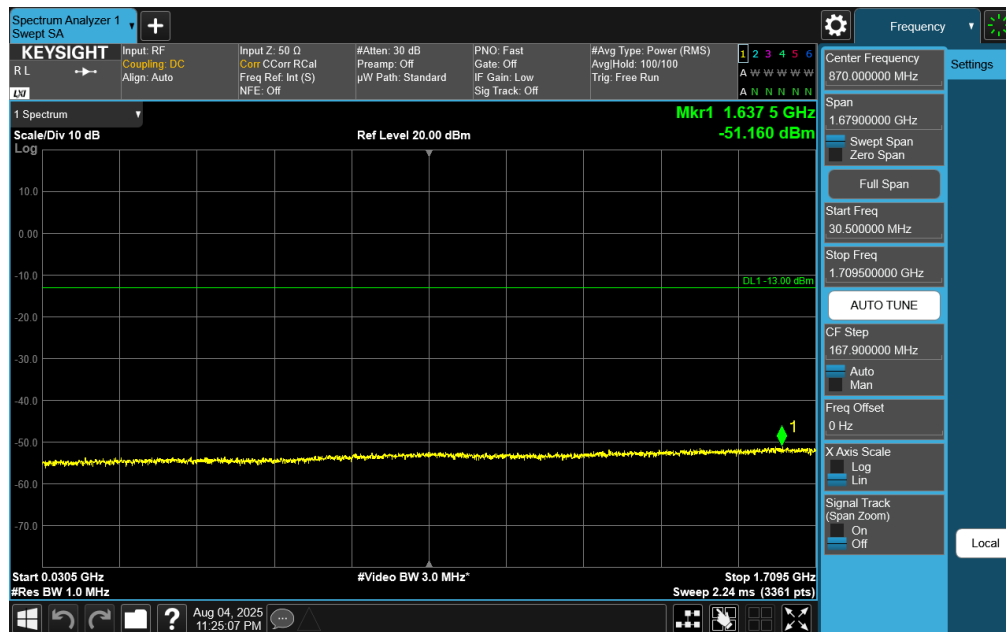


Plot 7-201. Conducted Spurious Plot (NR Band n66 - 45.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

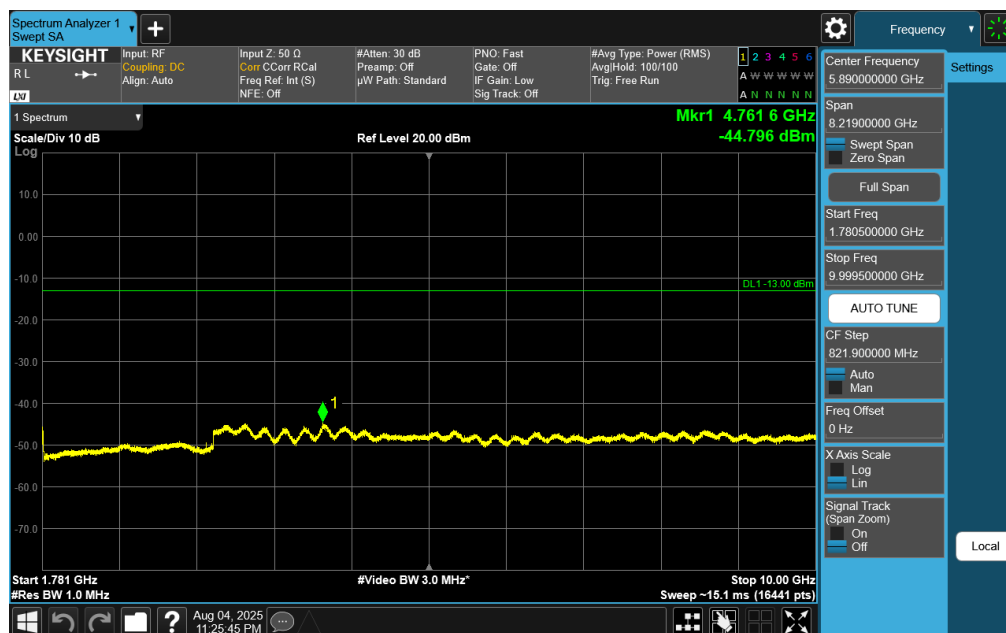
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 125 of 360

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Plot 7-202. Conducted Spurious Plot (NR Band n66 - 45.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

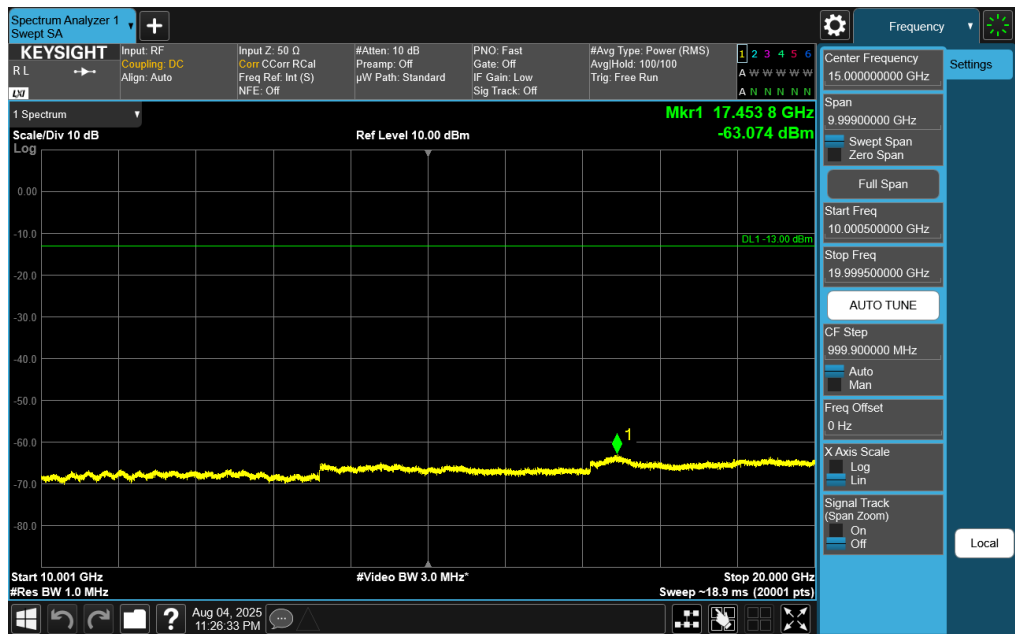


Plot 7-203. Conducted Spurious Plot (NR Band n66 - 45.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 126 of 360

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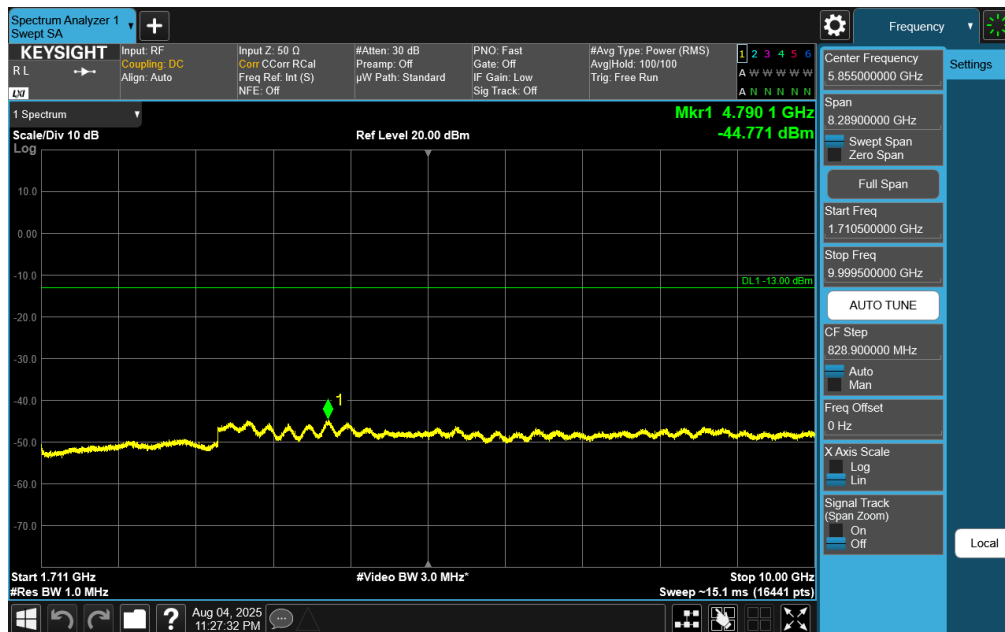
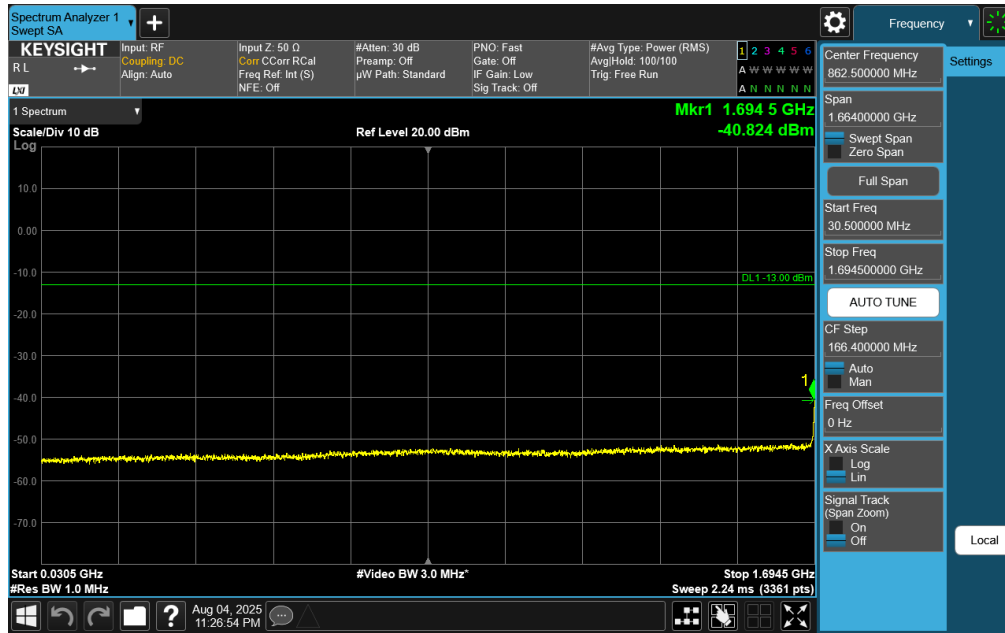
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Plot 7-204. Conducted Spurious Plot (NR Band n66 - 45.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 127 of 360

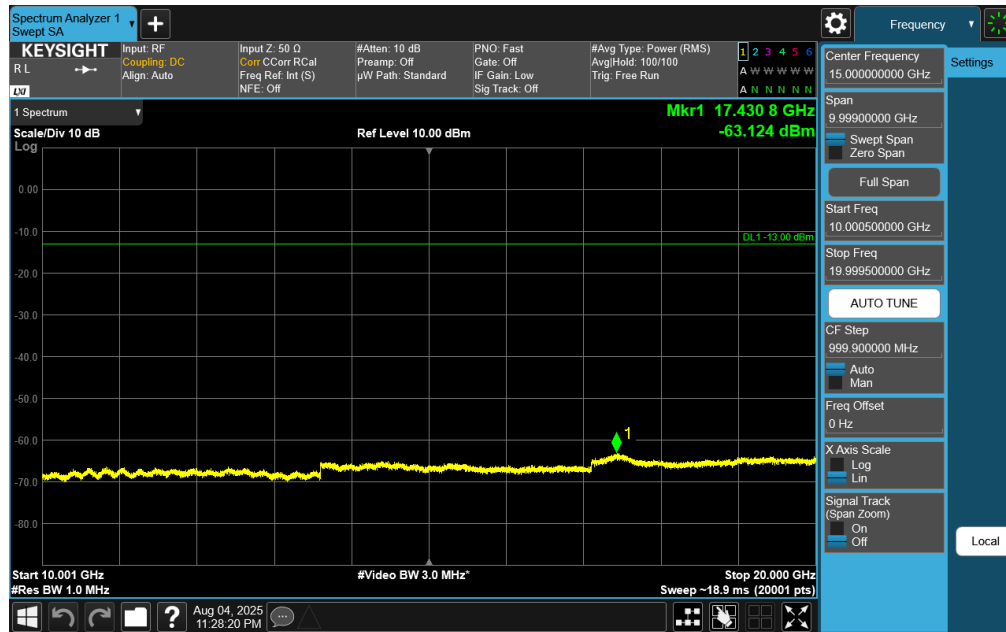
NR Band n70



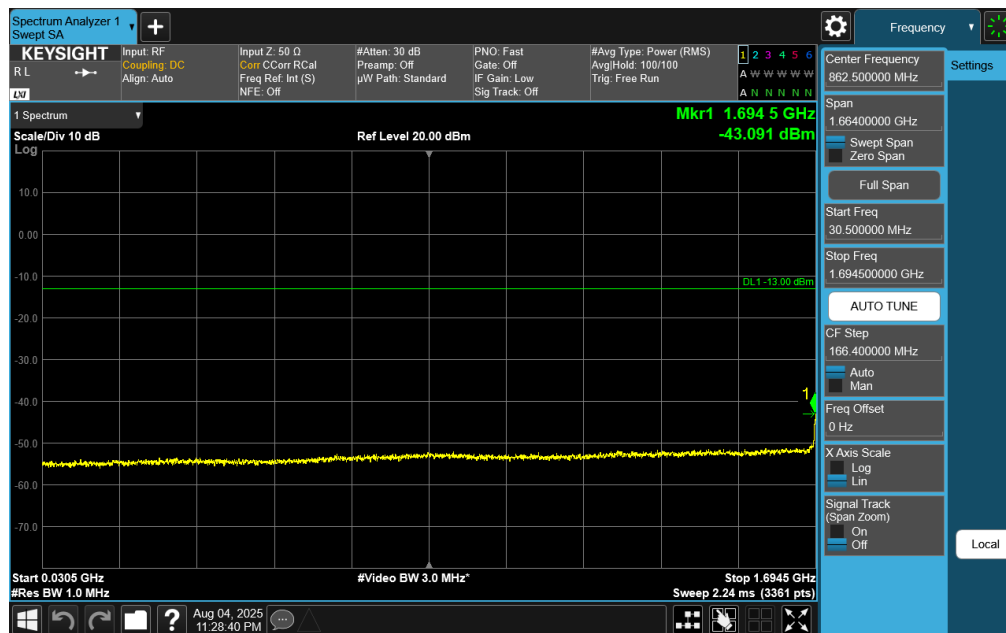
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 128 of 360

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Plot 7-207. Conducted Spurious Plot (NR Band n70 - 10.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Low Channel)

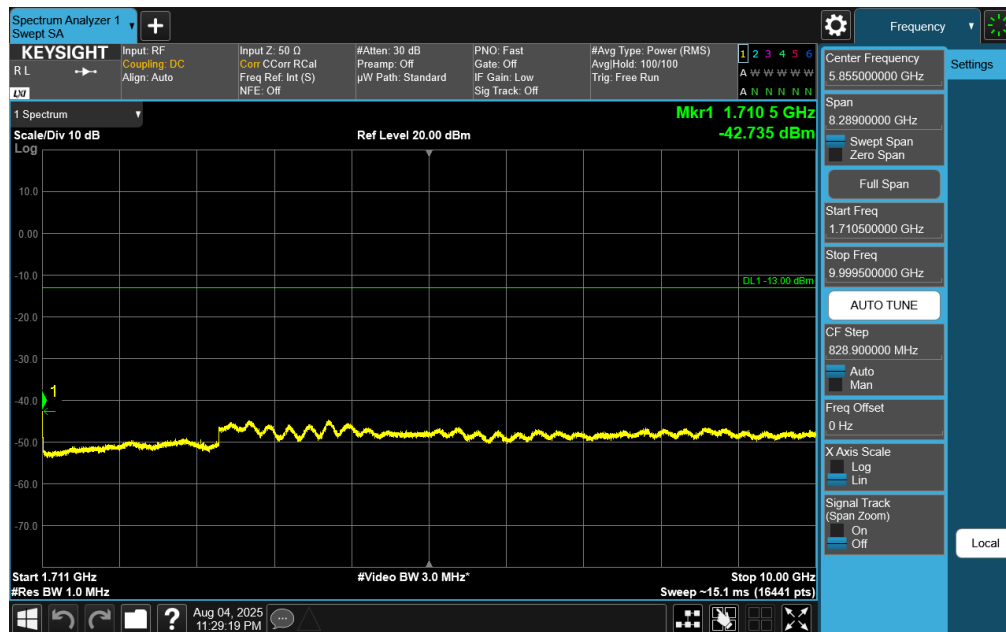


Plot 7-208. Conducted Spurious Plot (NR Band n70 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

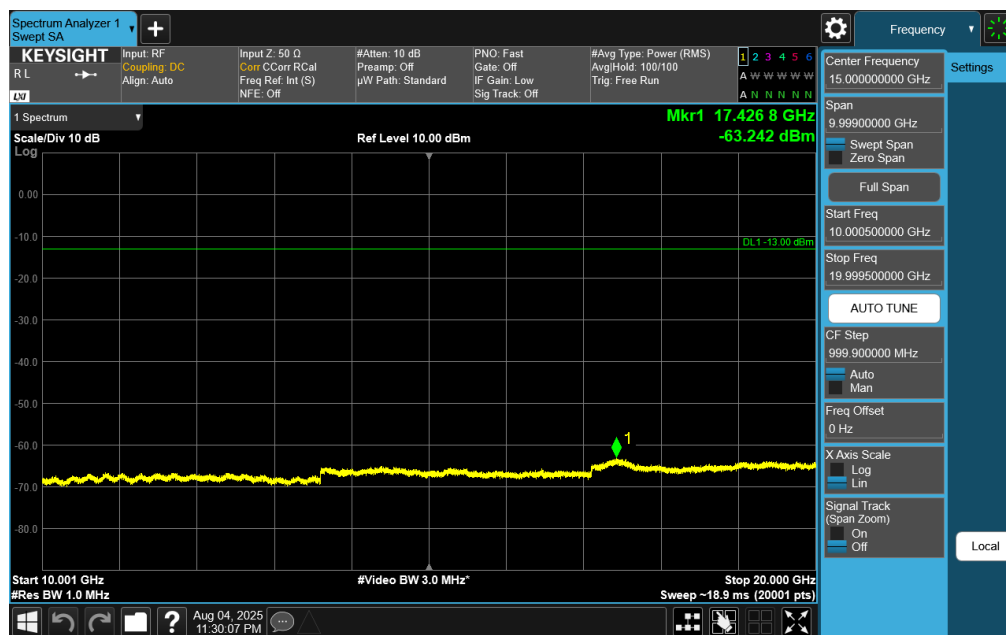
FCC ID: BCGA3460	element	PART 27 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 129 of 360

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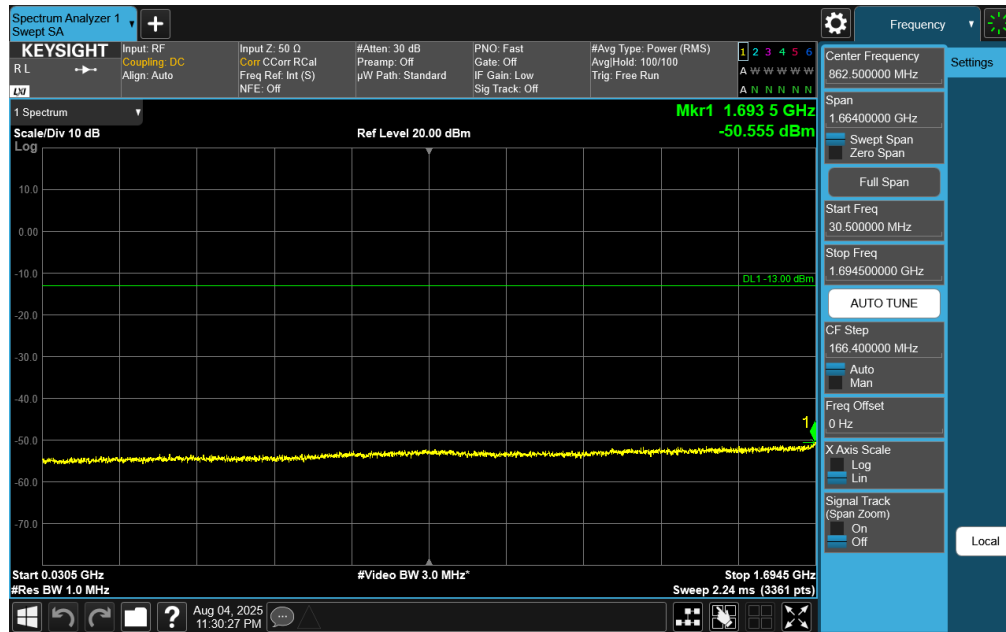
Plot 7-209. Conducted Spurious Plot (NR Band n70 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)



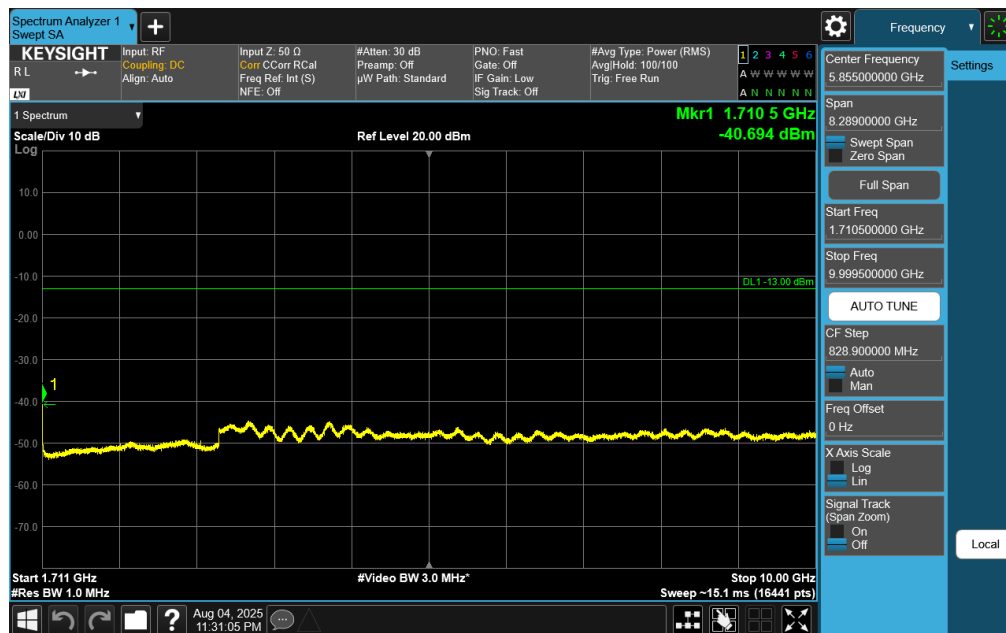
Plot 7-210. Conducted Spurious Plot (NR Band n70 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: BCGA3460	element PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 130 of 360

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Plot 7-211. Conducted Spurious Plot (NR Band n70 - 10.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

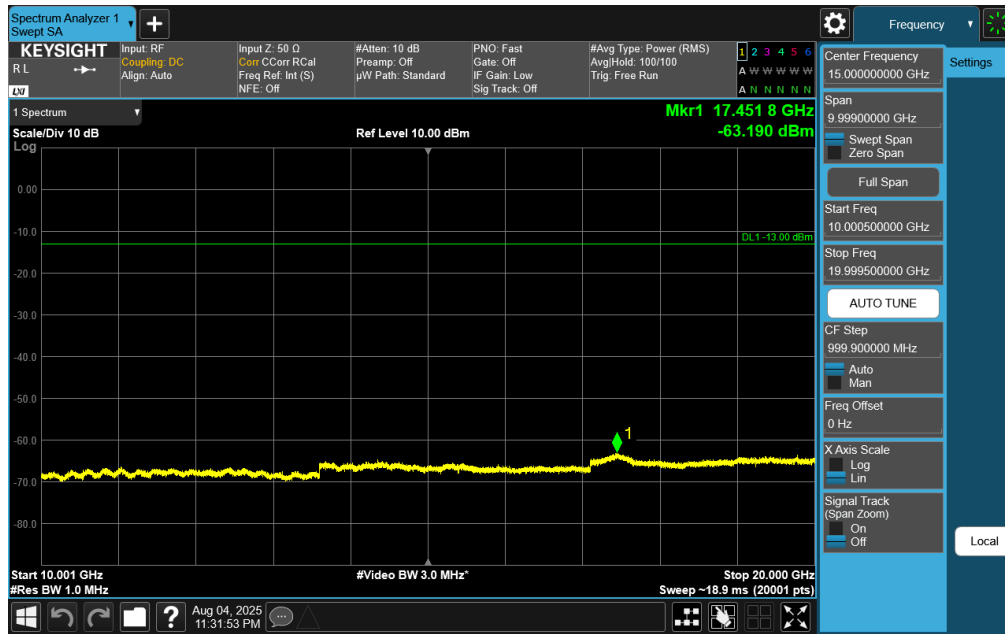


Plot 7-212. Conducted Spurious Plot (NR Band n70 - 10.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 131 of 360

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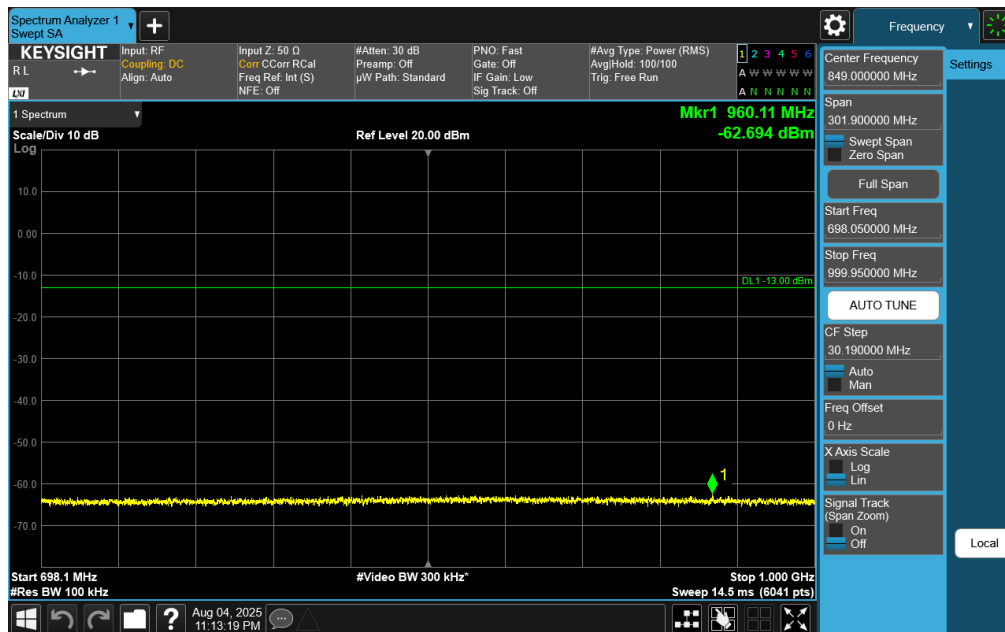
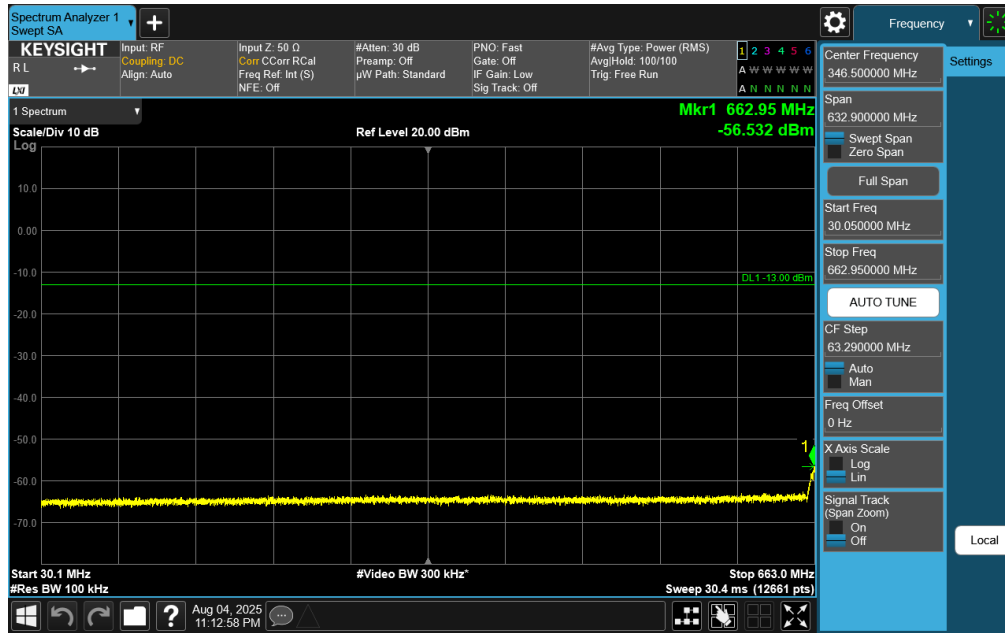
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Plot 7-213. Conducted Spurious Plot (NR Band n70 - 10.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	element PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 132 of 360

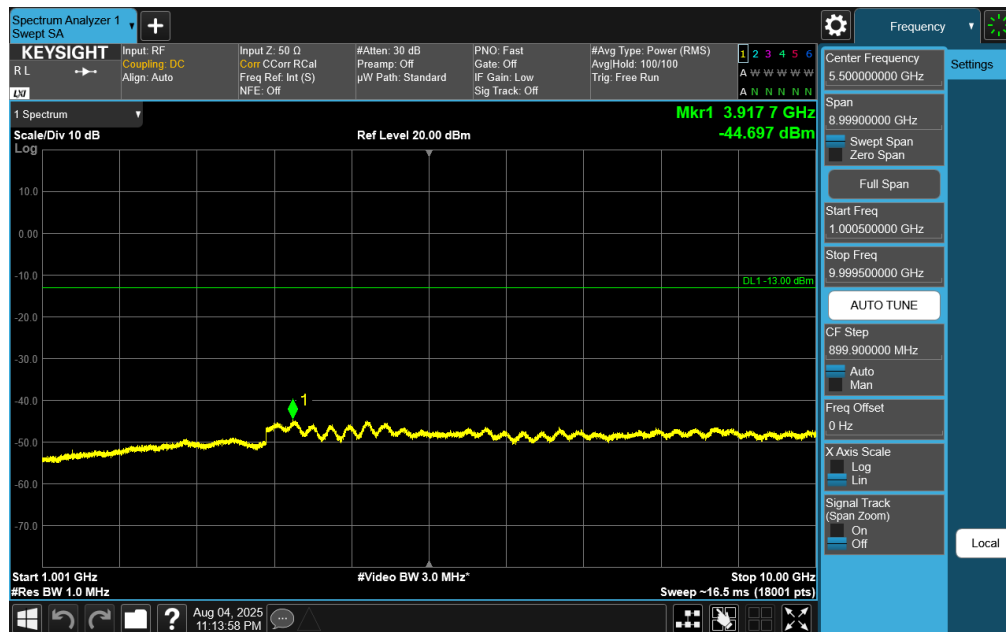
NR Band n71



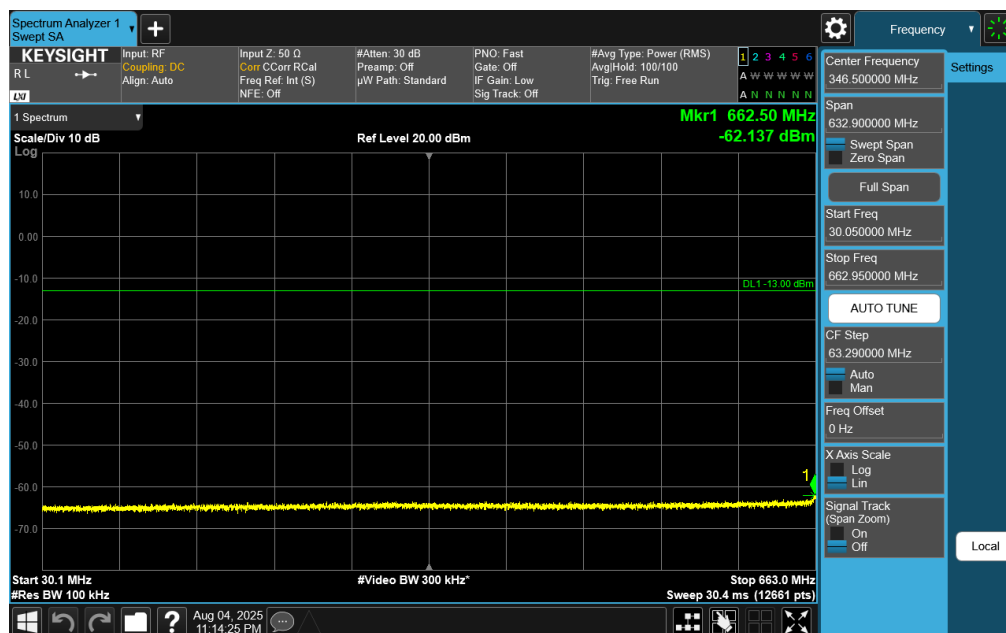
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 133 of 360

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Plot 7-216. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Low Channel)

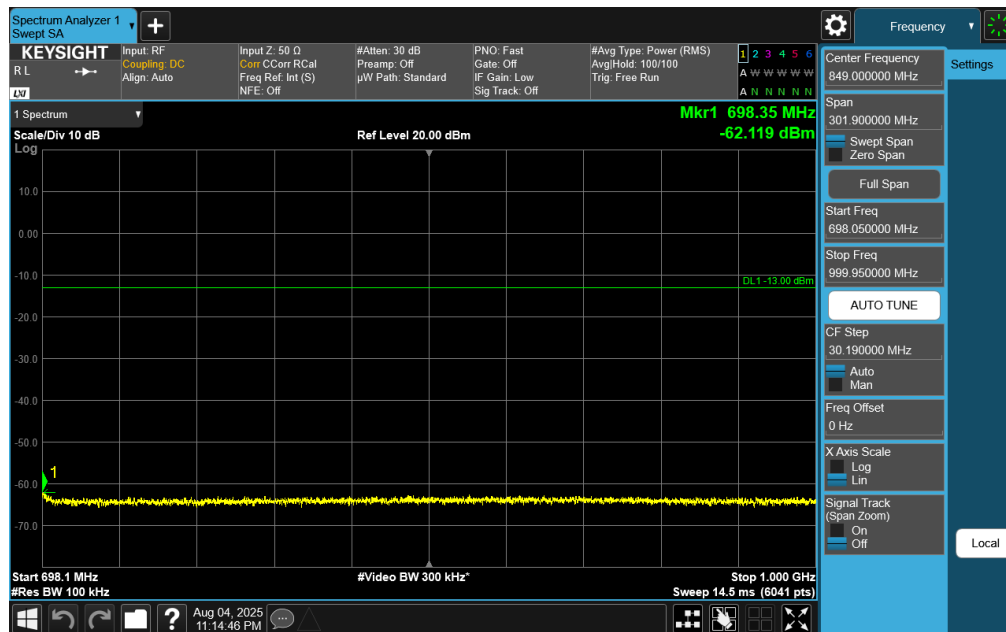


Plot 7-217. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

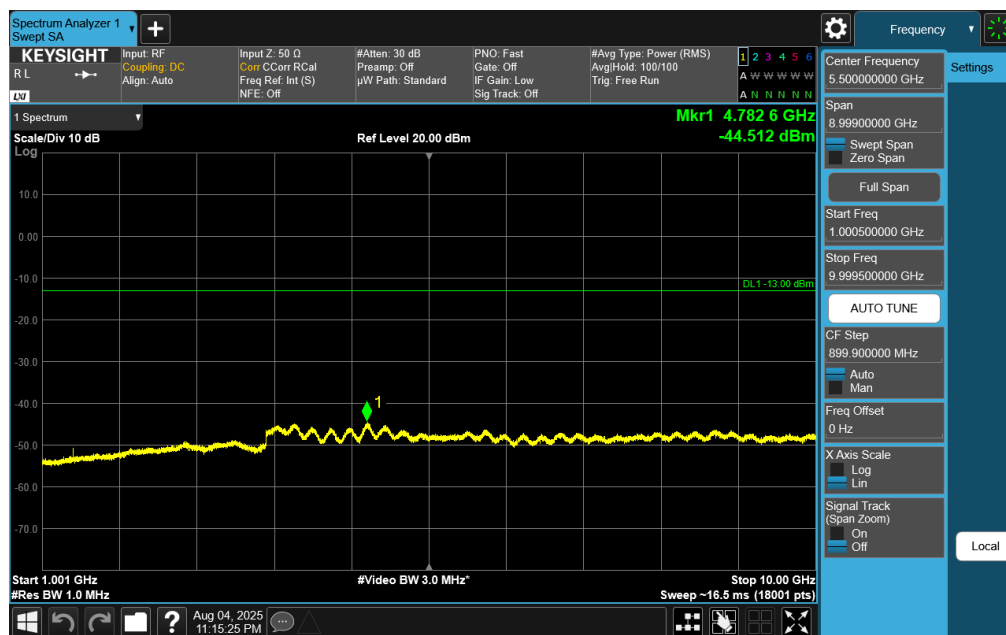
FCC ID: BCGA3460	element	PART 27 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 134 of 360

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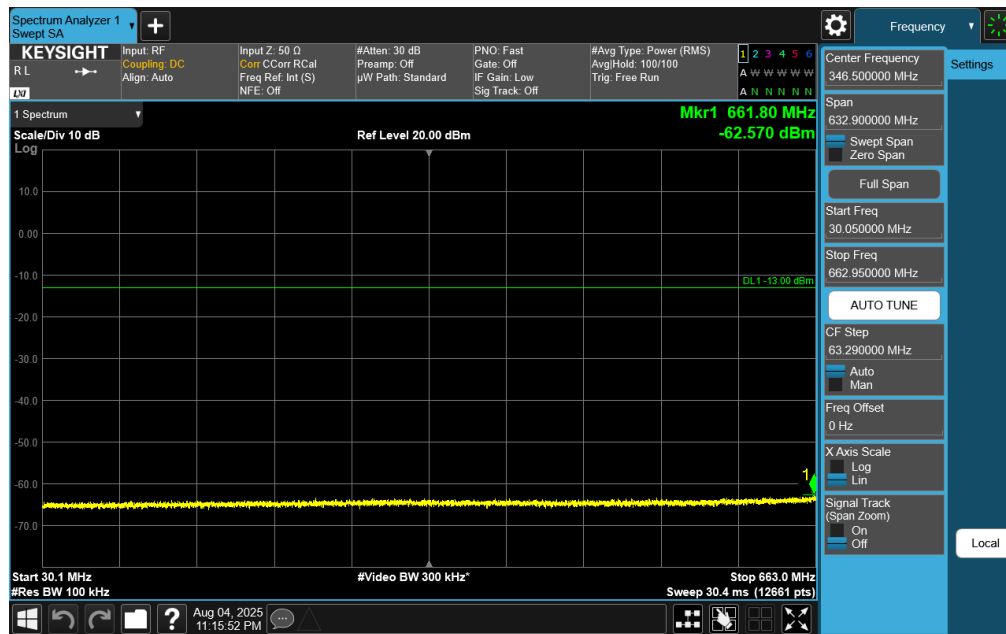


Plot 7-218. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

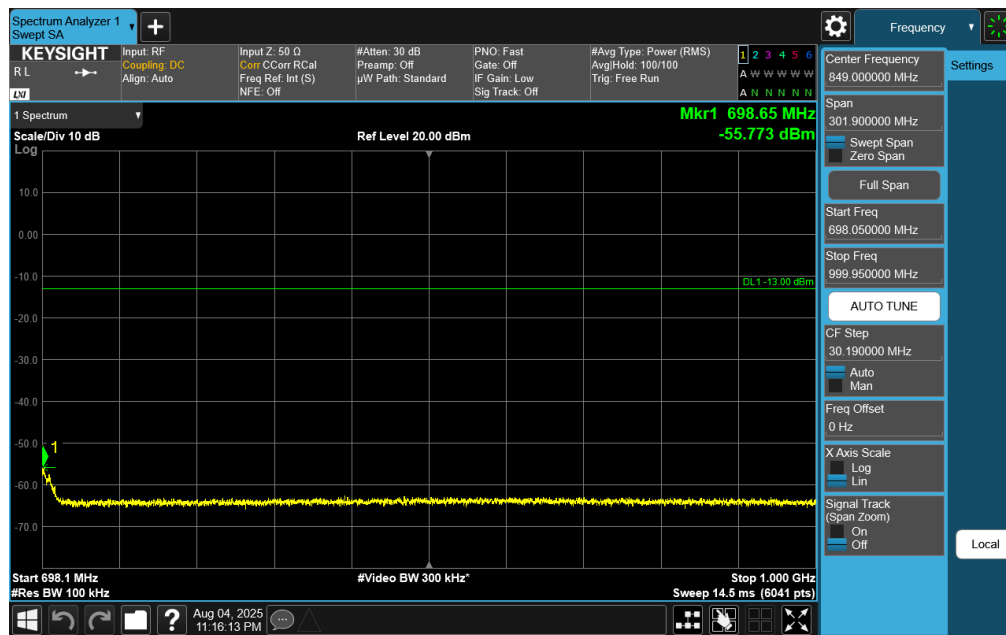


Plot 7-219. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: BCGA3460	element PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 135 of 360

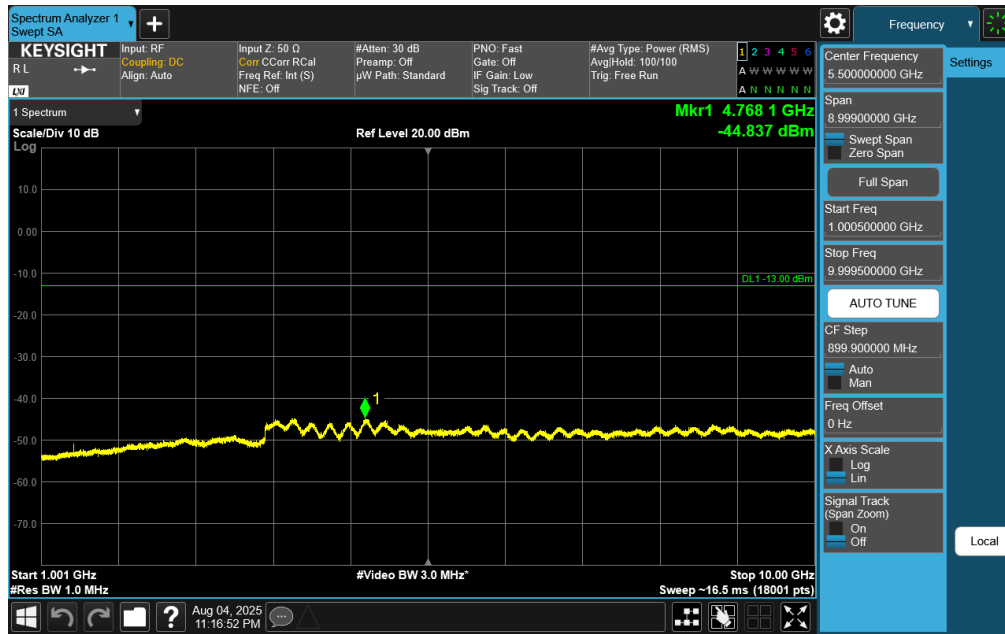


Plot 7-220. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-221. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

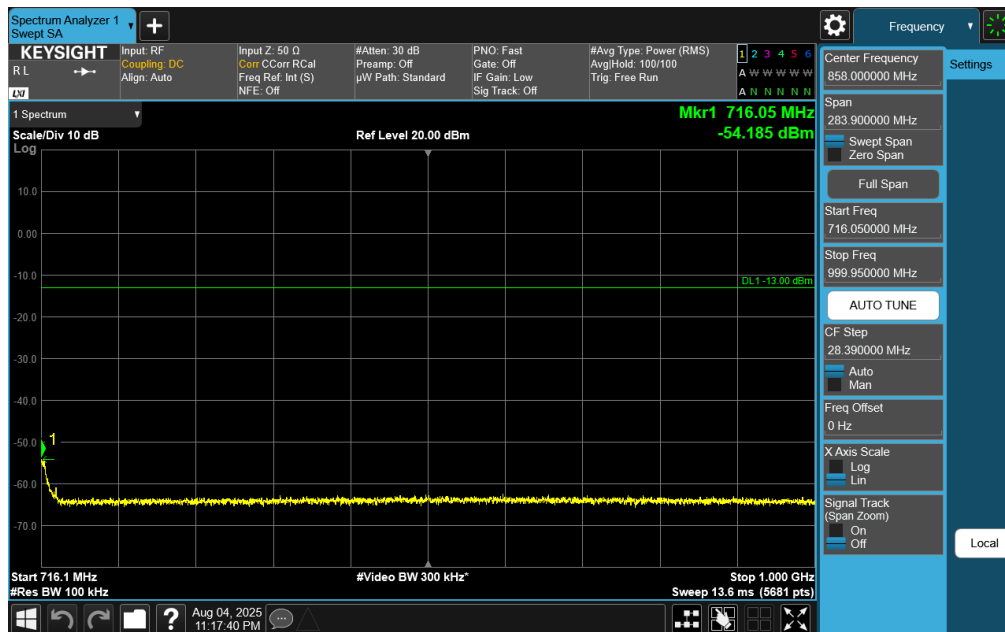
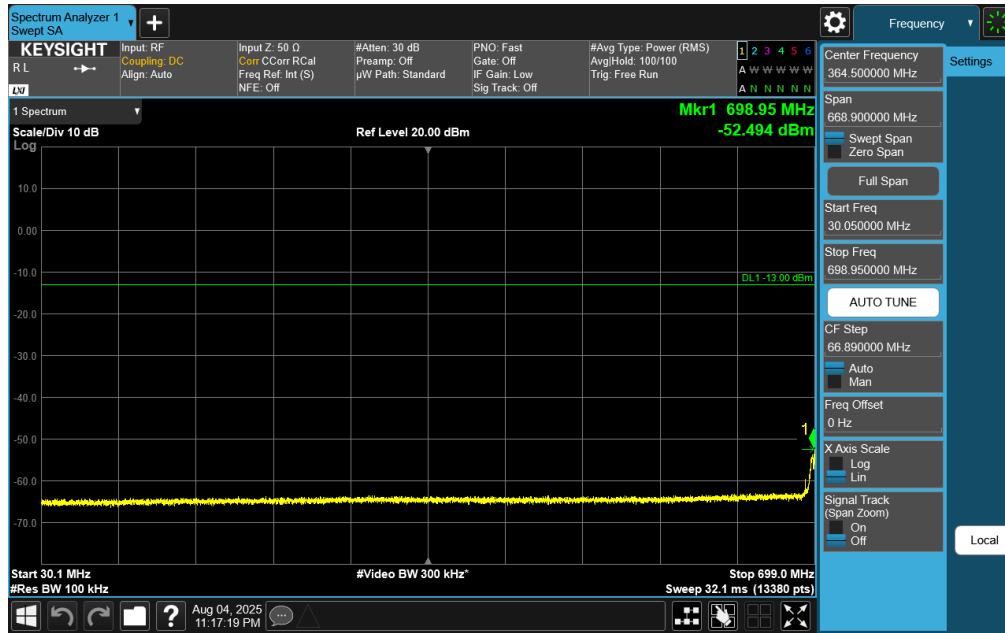
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 136 of 360



Plot 7-222. Conducted Spurious Plot (NR Band n71 - 20.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	element PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 137 of 360

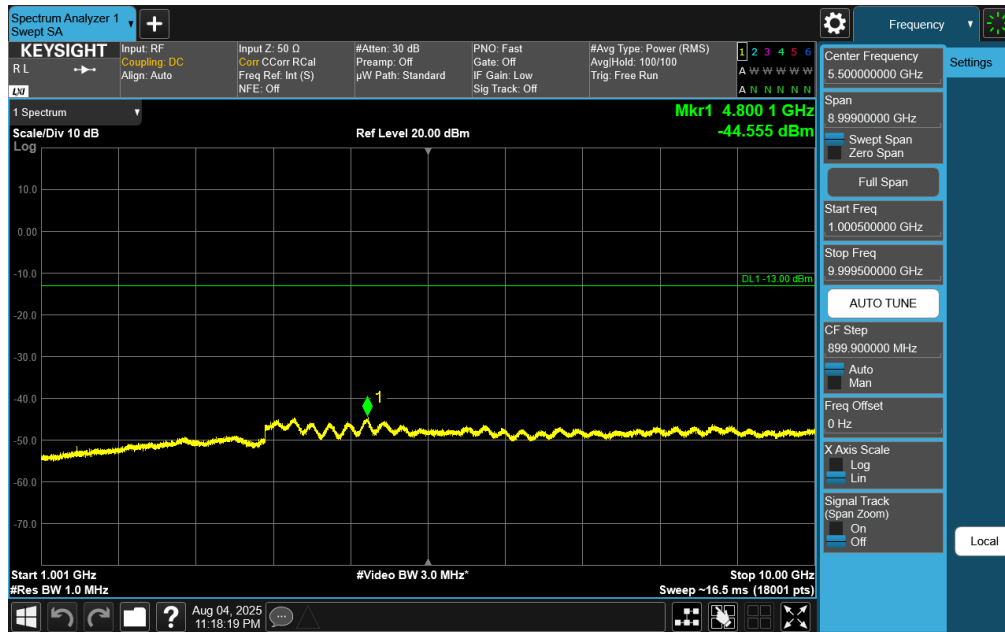
NR Band n12



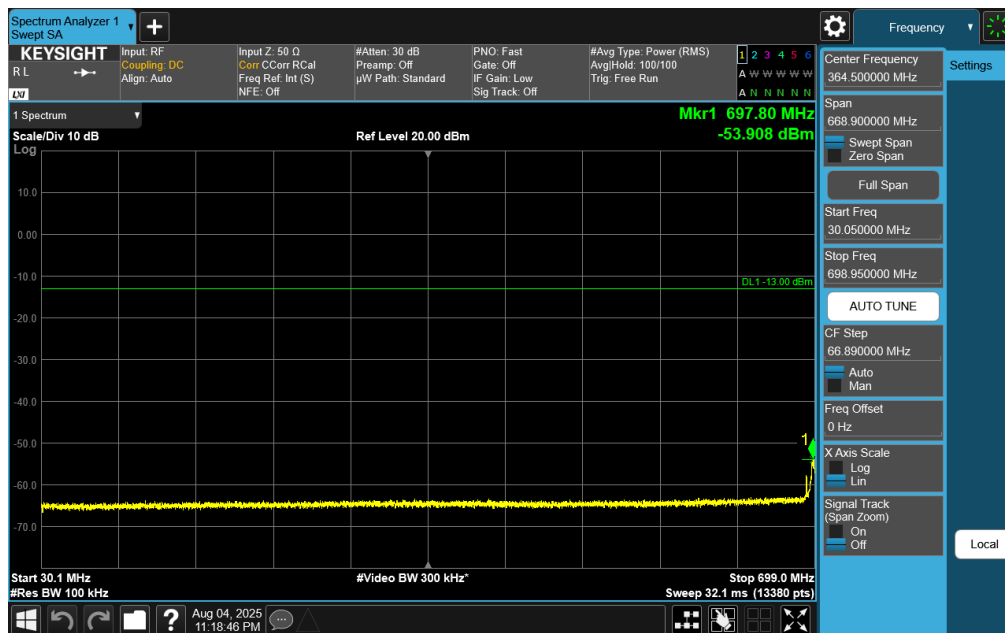
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 138 of 360

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Plot 7-225. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Low Channel)

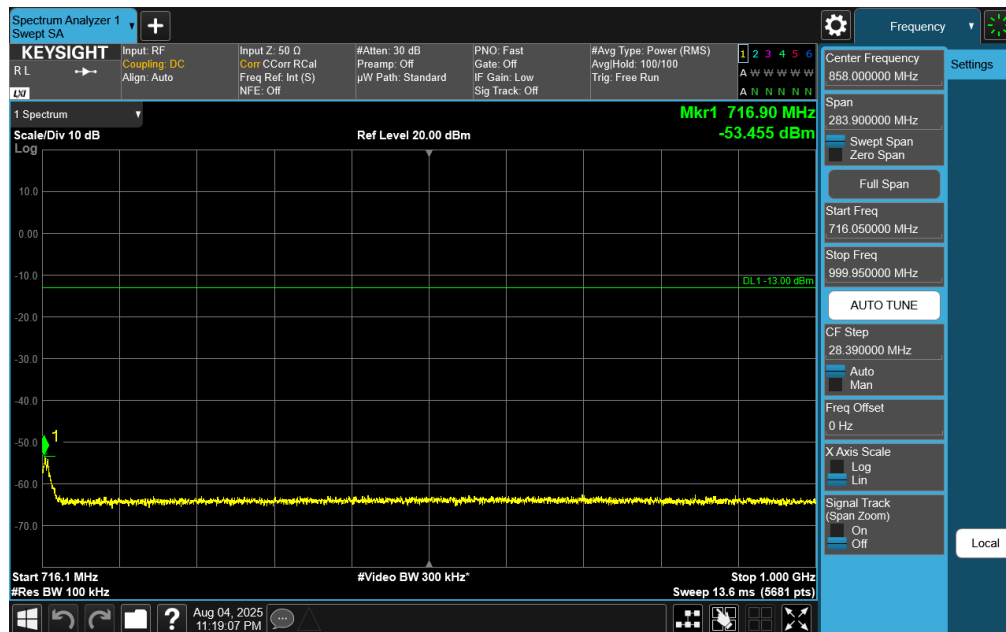


Plot 7-226. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

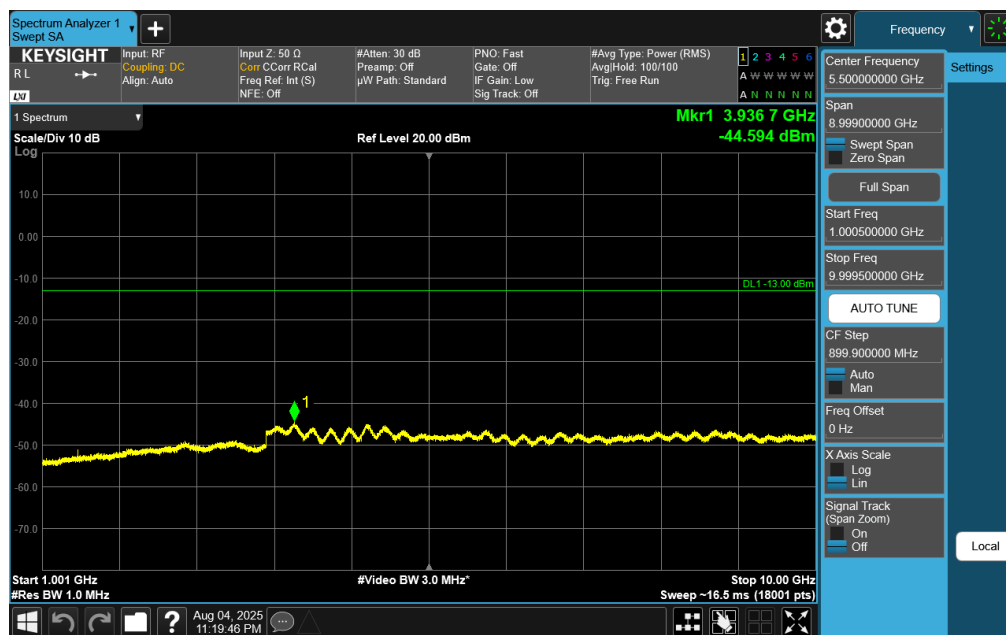
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 139 of 360

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Plot 7-227. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

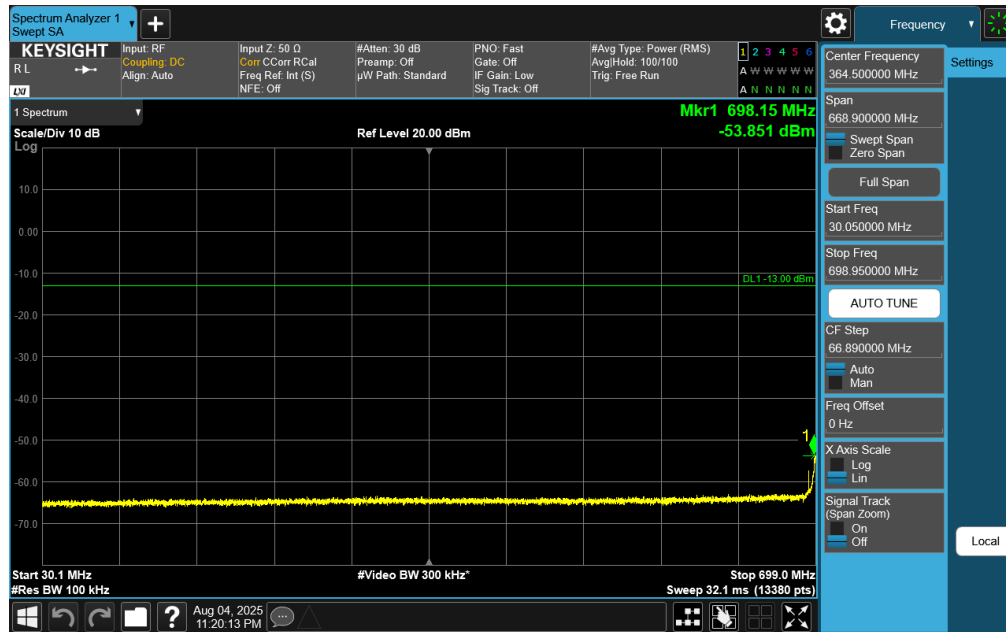


Plot 7-228. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - Mid Channel)

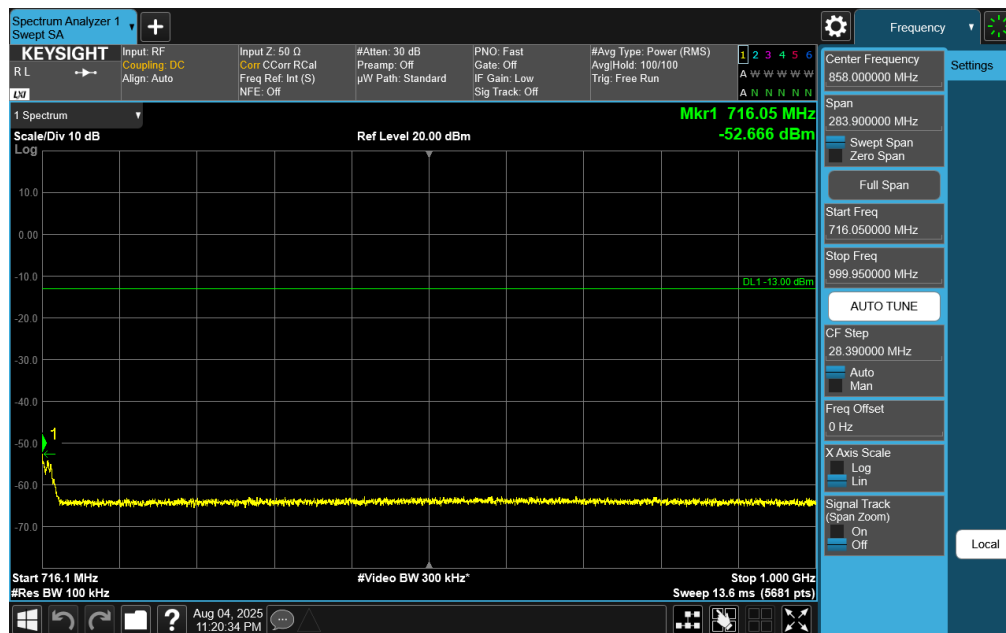
FCC ID: BCGA3460	element	PART 27 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 140 of 360

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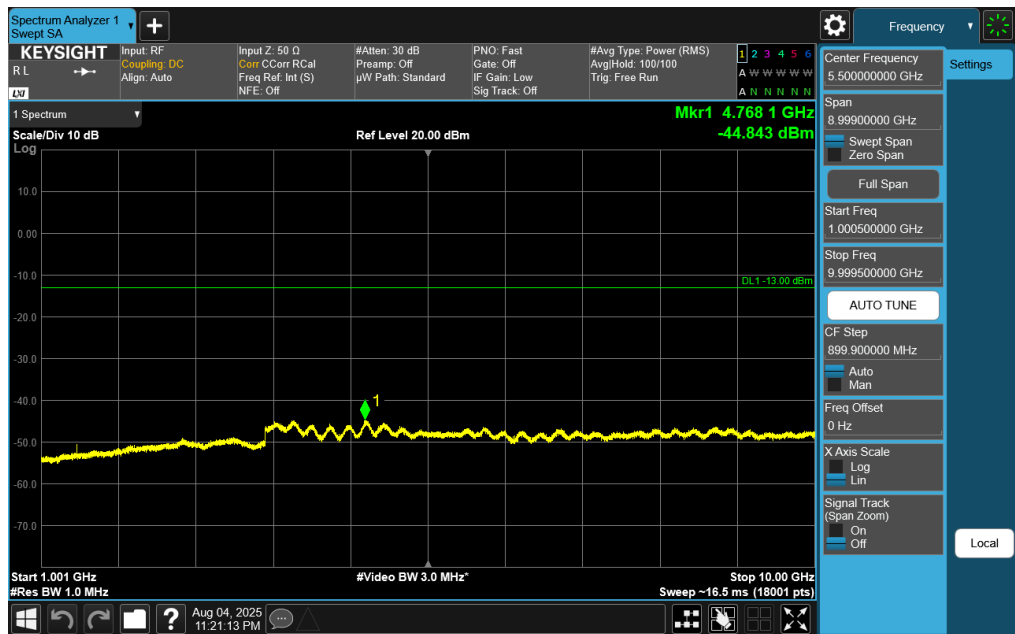


Plot 7-229. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)



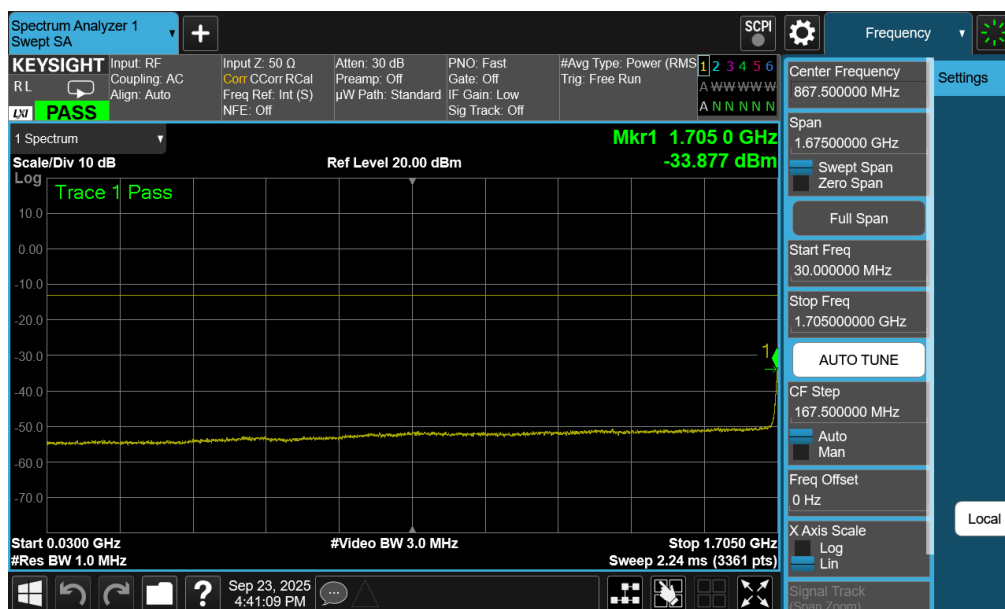
Plot 7-230. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 141 of 360

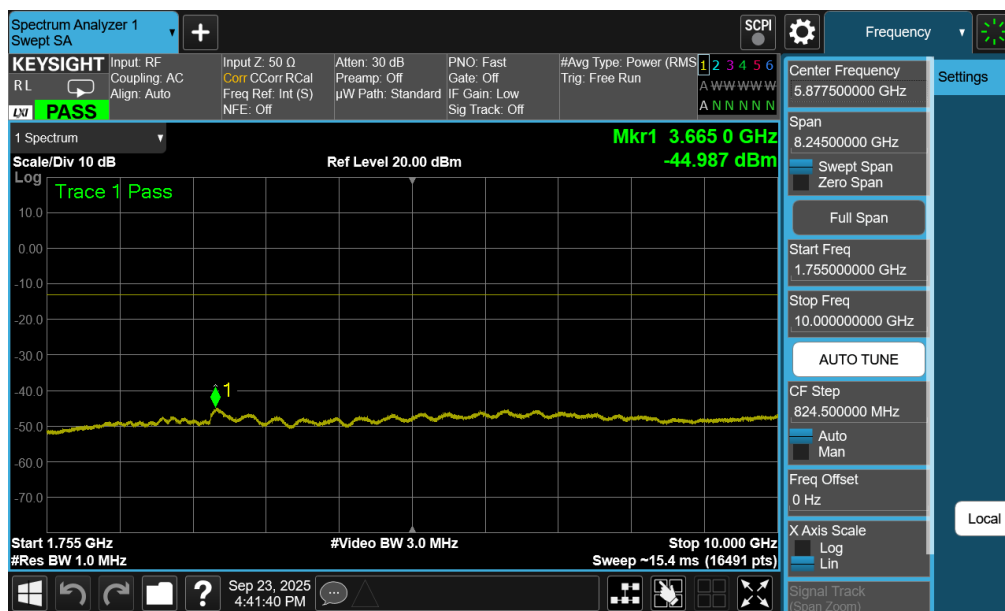


Plot 7-231. Conducted Spurious Plot (NR Band n12 - 15.0MHz DFT-s-OFDM QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCGA3460	element PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 142 of 360

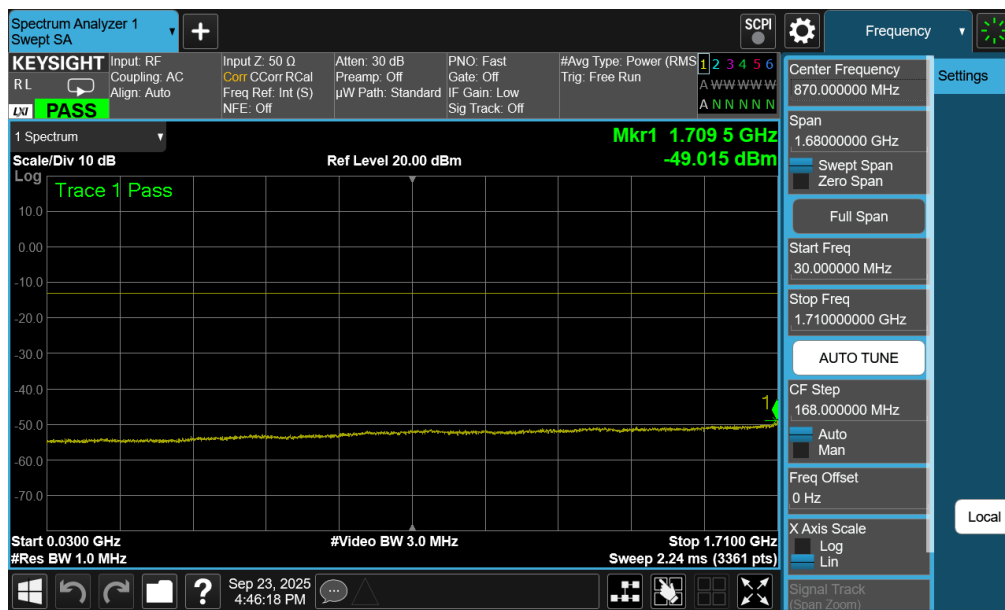
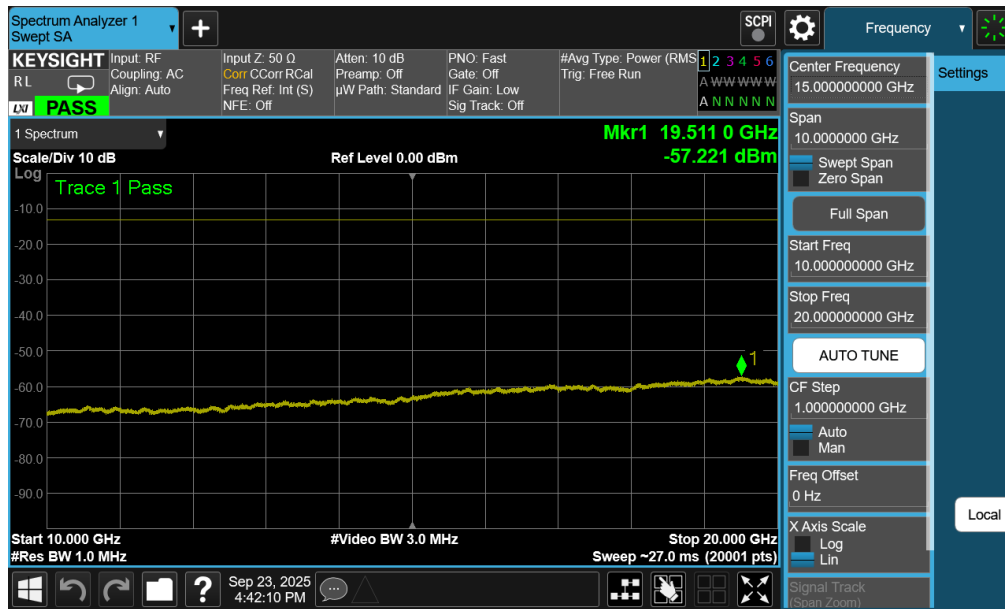


Plot 7-232. Conducted Spurious Plot (WCDMA Ch. 1312- Low Channel)



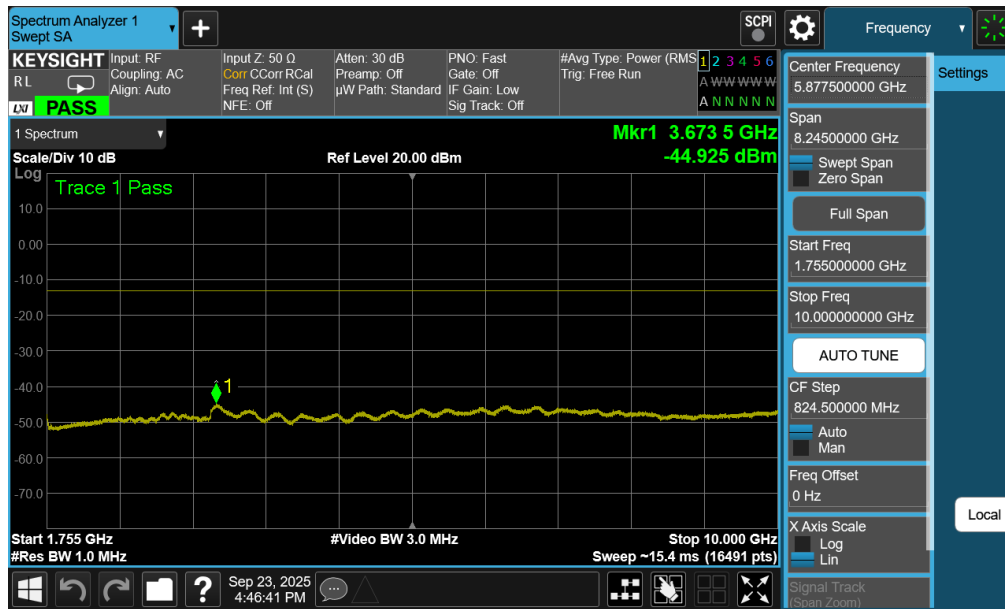
Plot 7-233. Conducted Spurious Plot (WCDMA Ch. 1312- Low Channel)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 143 of 360

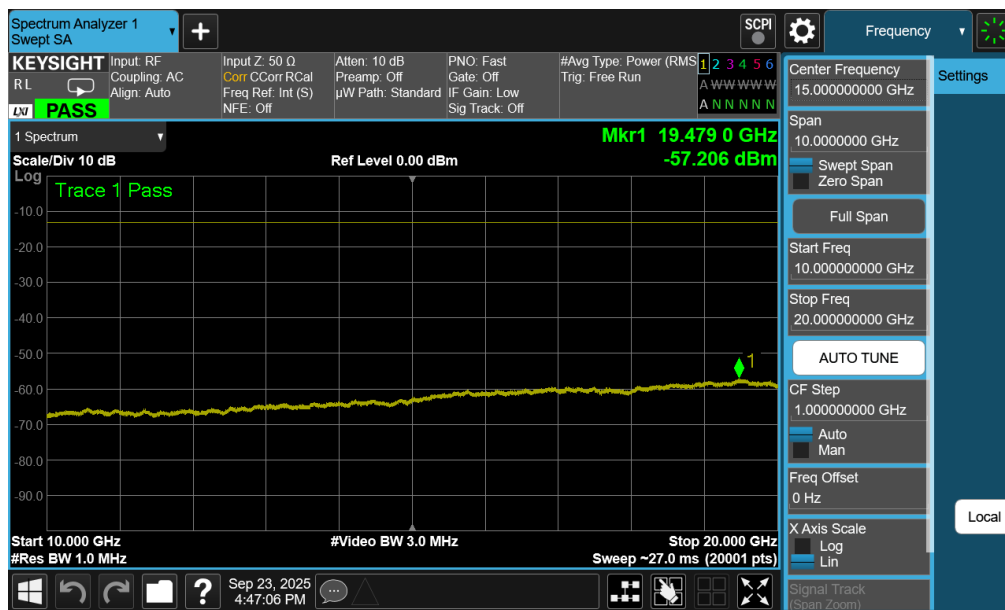


FCC ID: BCGA3460	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 144 of 360

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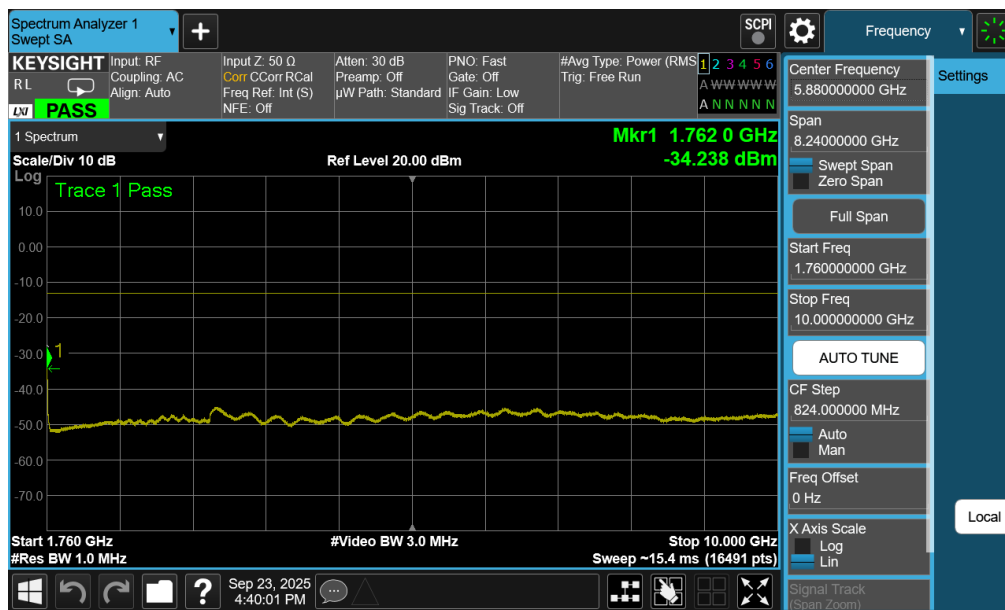
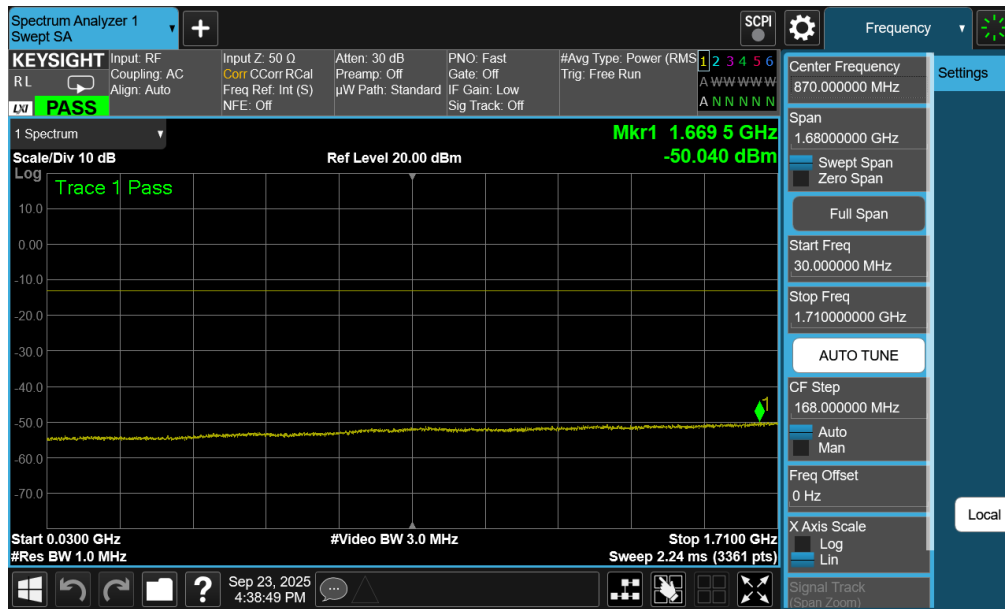
Plot 7-236. Conducted Spurious Plot (WCDMA Ch. 1413- Mid Channel)



Plot 7-237. Conducted Spurious Plot (WCDMA Ch. 1413- Mid Channel)

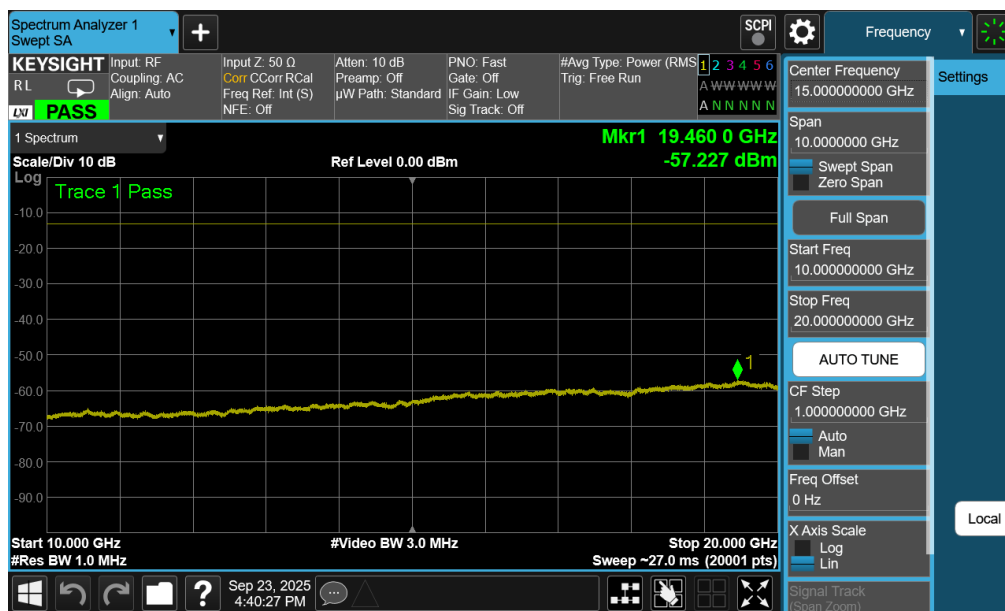
FCC ID: BCGA3460	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2509100080-09-R3.BCG	Test Dates: 07/01/2025 - 10/23/2025	EUT Type: Tablet Device	Page 145 of 360

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Plot 7-240. Conducted Spurious Plot (WCDMA Ch. 1513- High Channel)

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7.4 Band Edge Emissions at Antenna Terminal

\$2.1051, \$27.53

Test Overview and Limit

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section. All ports were tested and only the worst case data was reported.

The minimum permissible attenuation level of any spurious emission is $43 + 10 \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW $\geq 1\%$ of the emission bandwidth
4. VBW $\geq 3 \times$ RBW
5. Detector = RMS
6. Number of sweep points $\geq 2 \times$ Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

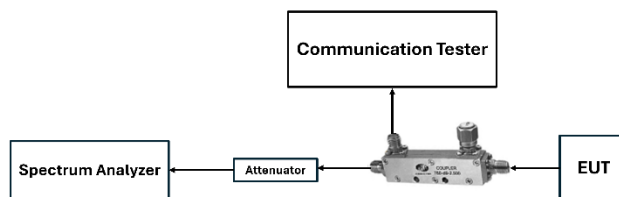


Figure 7-5. LTE Test Instrument & Measurement Setup

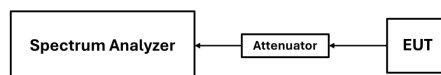


Figure 7-6. FR1 Test Instrument & Measurement Setup

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Test Notes

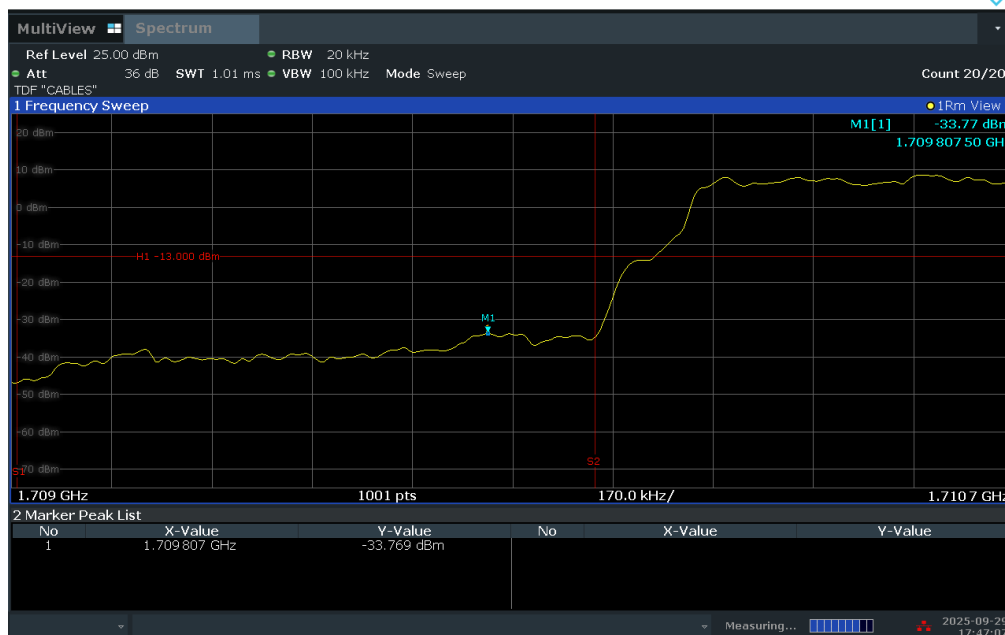
1. Per 27.53(h) in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.
2. Per 27.53(g) for operations in the 663 - 698 MHz and 698 – 746MHz bands, in the 100 kHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit.
3. Per 27.53(c)(5) for operations in the 776-788 MHz band, in the 100 kHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit.
4. For all plots showing emissions in the 763 – 775MHz and 793 – 805MHz band, the FCC limit per 27.53(c)(4) is $65 + 10 \log_{10}(P) = -35\text{dBm}$ in a 6.25kHz bandwidth.
5. For NR operation, all subcarrier spacings (SCS) and transmission schemes (e.g. CP-OFDM and DFT-s-OFDM) were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

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LTE Band 66

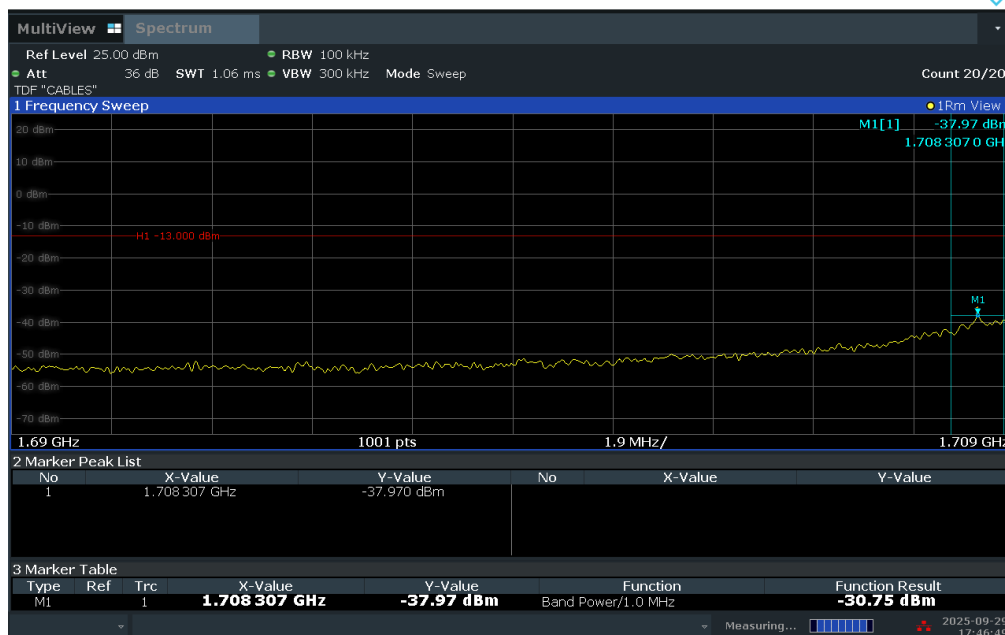
Test Plot



05:47:07 PM 09/29/2025

Plot 7-241. Lower Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)

Test Plot



05:46:50 PM 09/29/2025

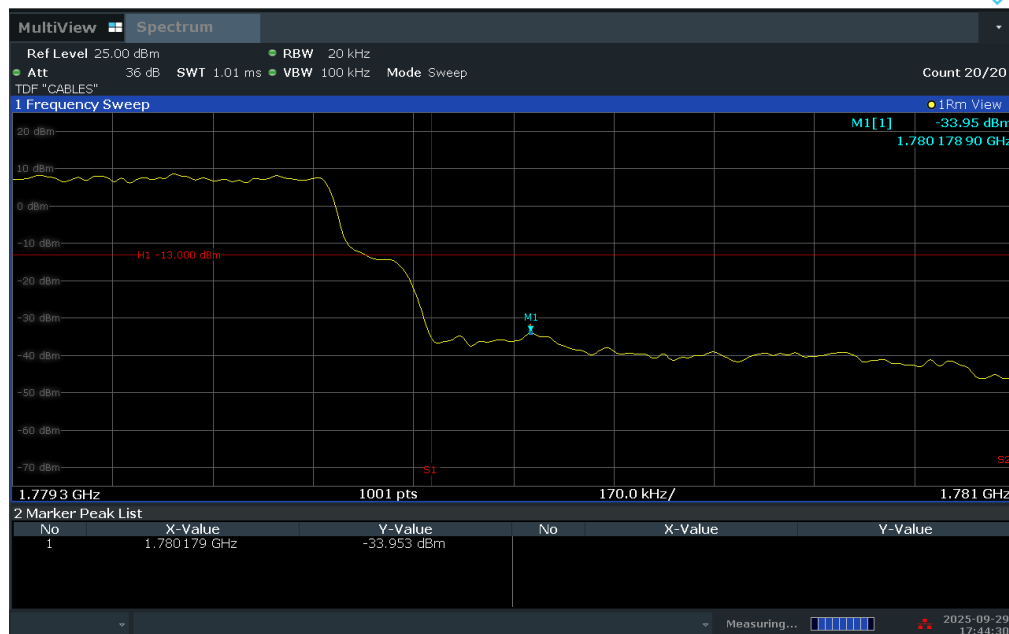
Plot 7-242. Lower Extended Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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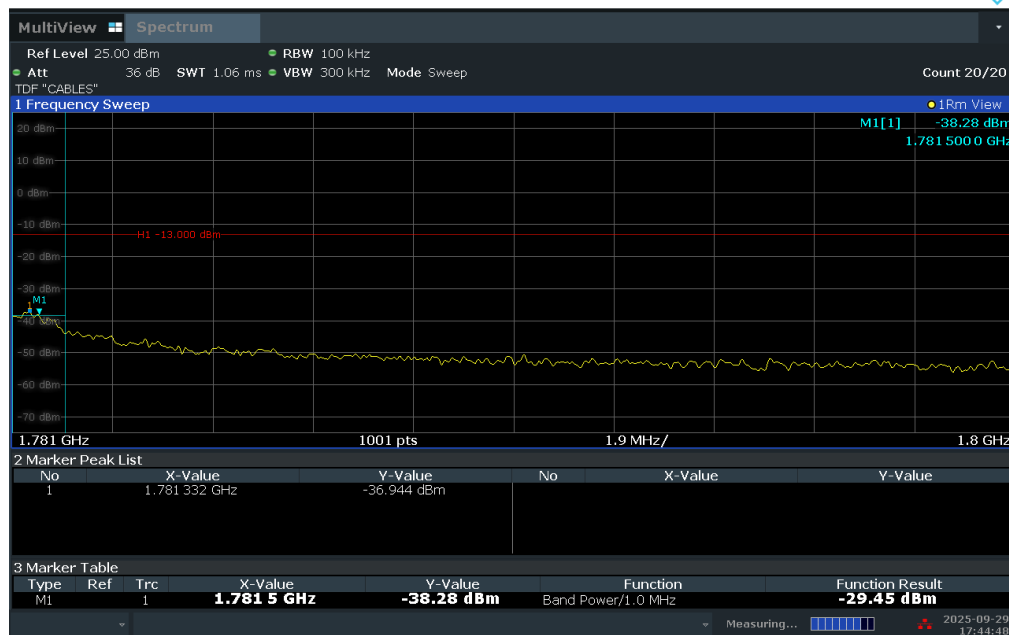
Test Plot



05:44:31 PM 09/29/2025

Plot 7-243. Upper Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)

Test Plot



05:44:48 PM 09/29/2025

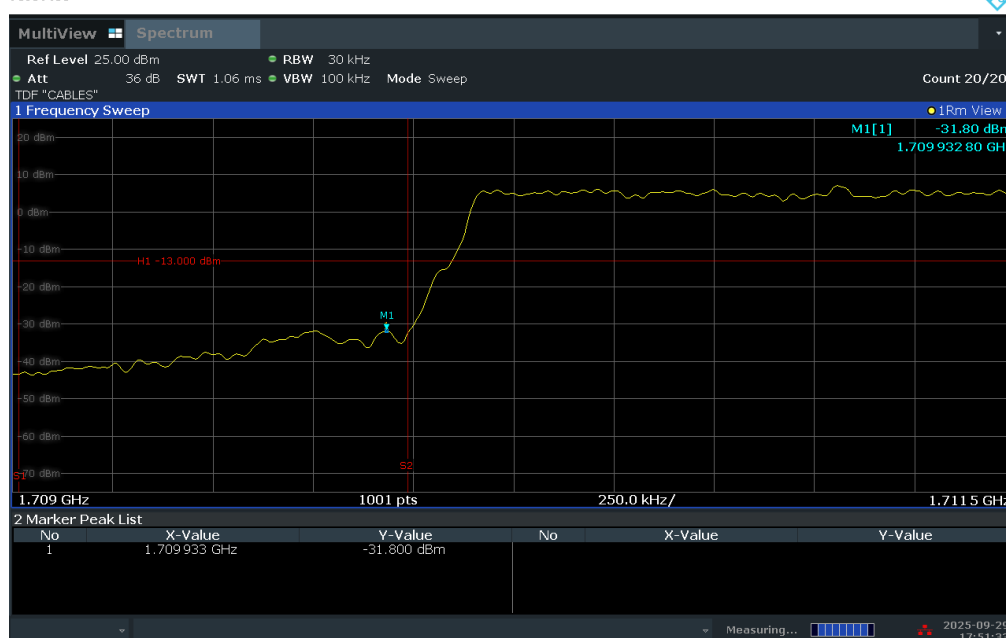
Plot 7-244. Upper Extended Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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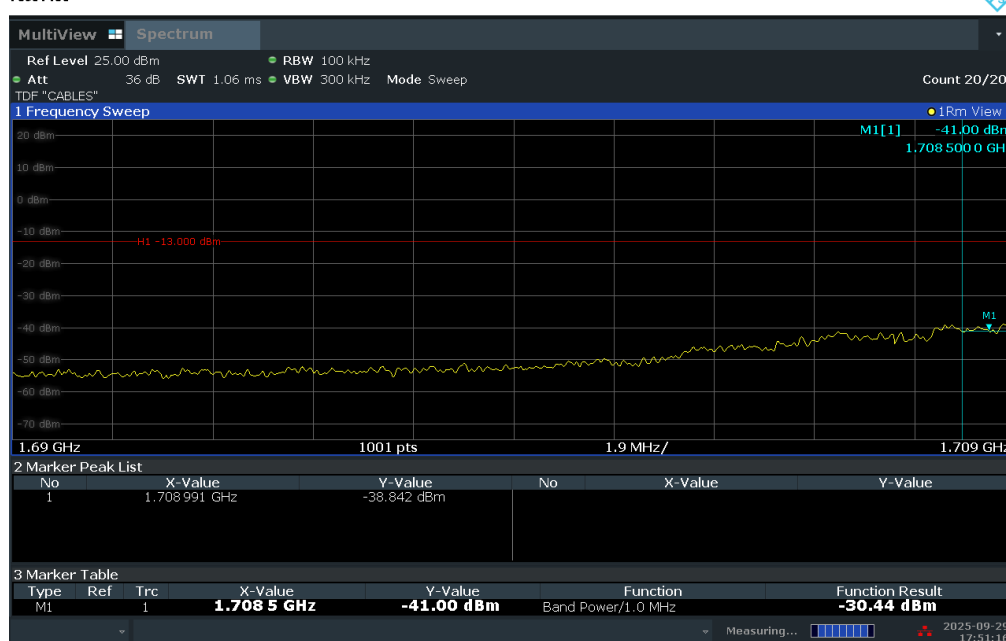
Test Plot



05:51:34 PM 09/29/2025

Plot 7-245. Lower Band Edge Plot (LTE Band 66 – 3MHz QPSK – Full RB)

Test Plot



05:51:17 PM 09/29/2025

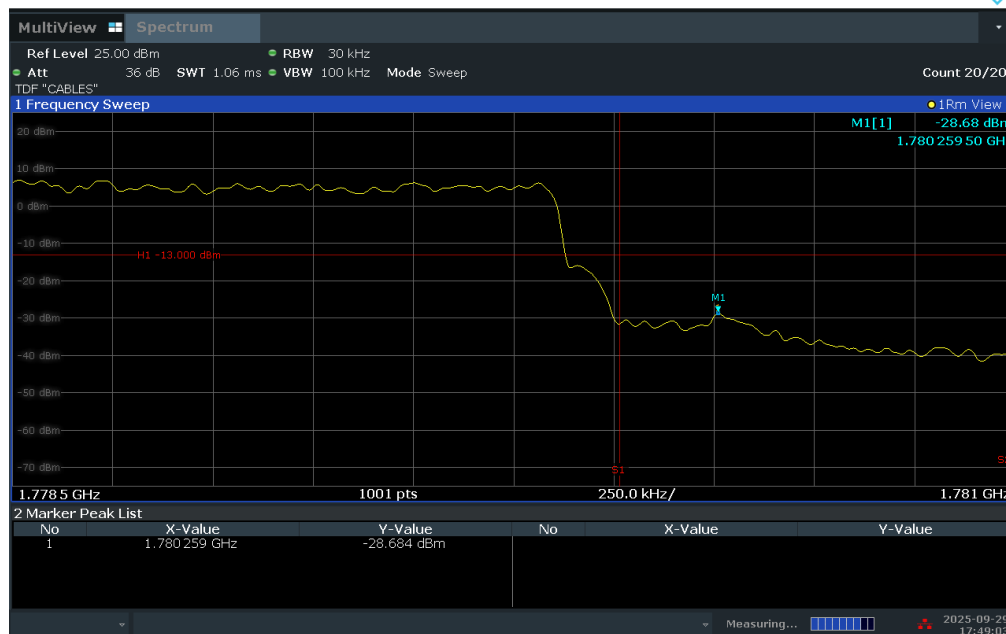
Plot 7-246. Lower Extended Band Edge Plot (LTE Band 66 – 3MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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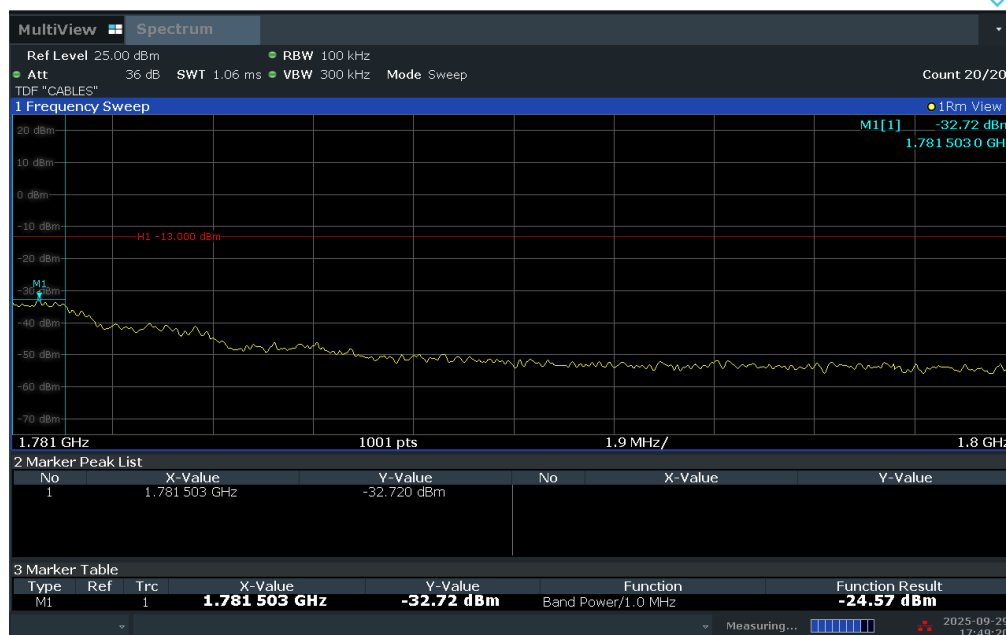
Test Plot



05:49:04 PM 09/29/2025

Plot 7-247. Upper Band Edge Plot (LTE Band 66 – 3MHz QPSK – Full RB)

Test Plot



05:49:21 PM 09/29/2025

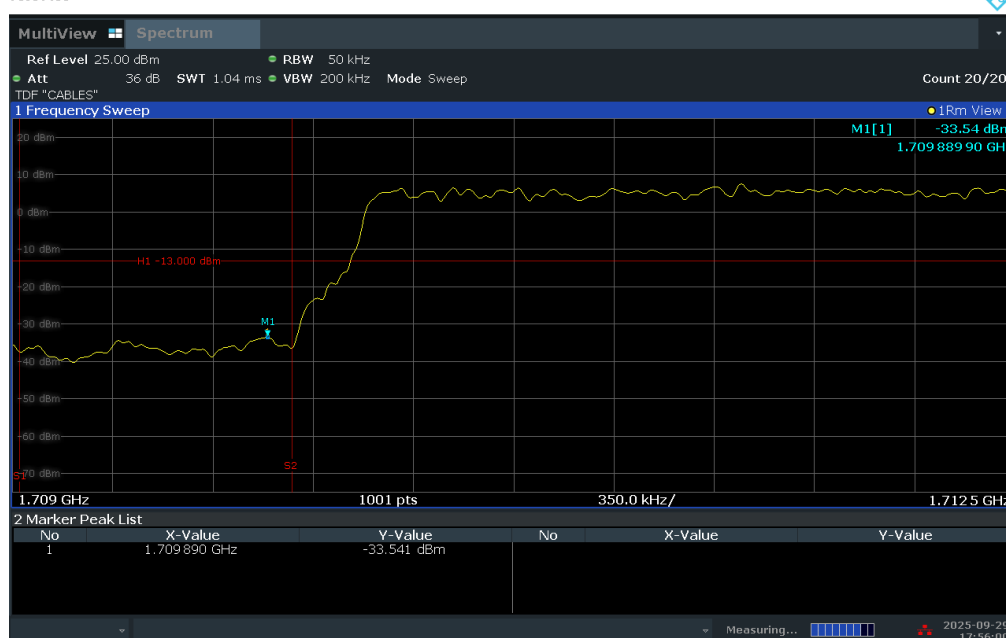
Plot 7-248. Upper Extended Band Edge Plot (LTE Band 66 – 3MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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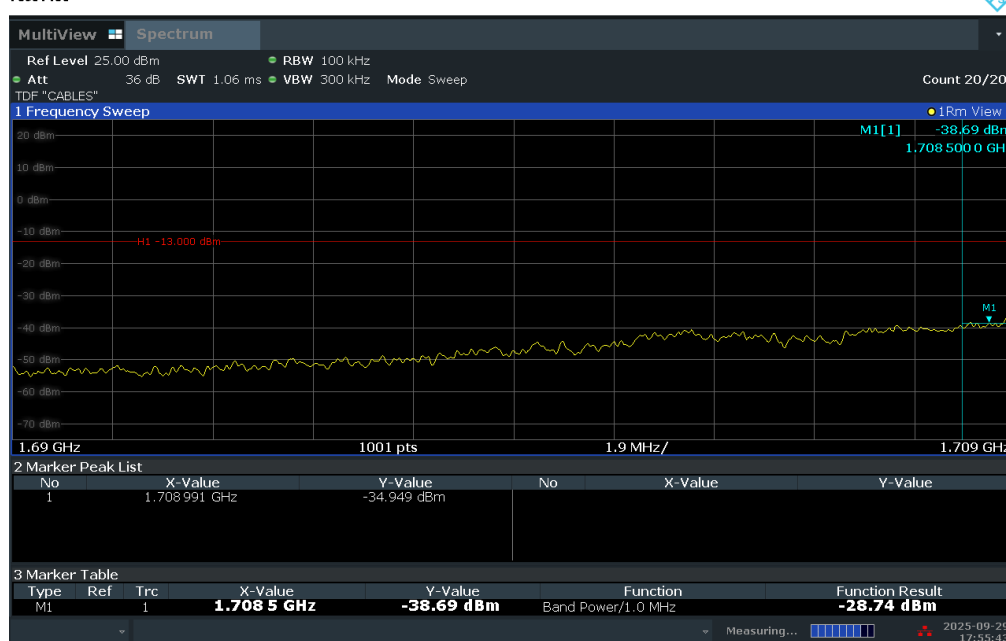
Test Plot



05:56:01 PM 09/29/2025

Plot 7-249. Lower Band Edge Plot (LTE Band 66 – 5MHz QPSK – Full RB)

Test Plot



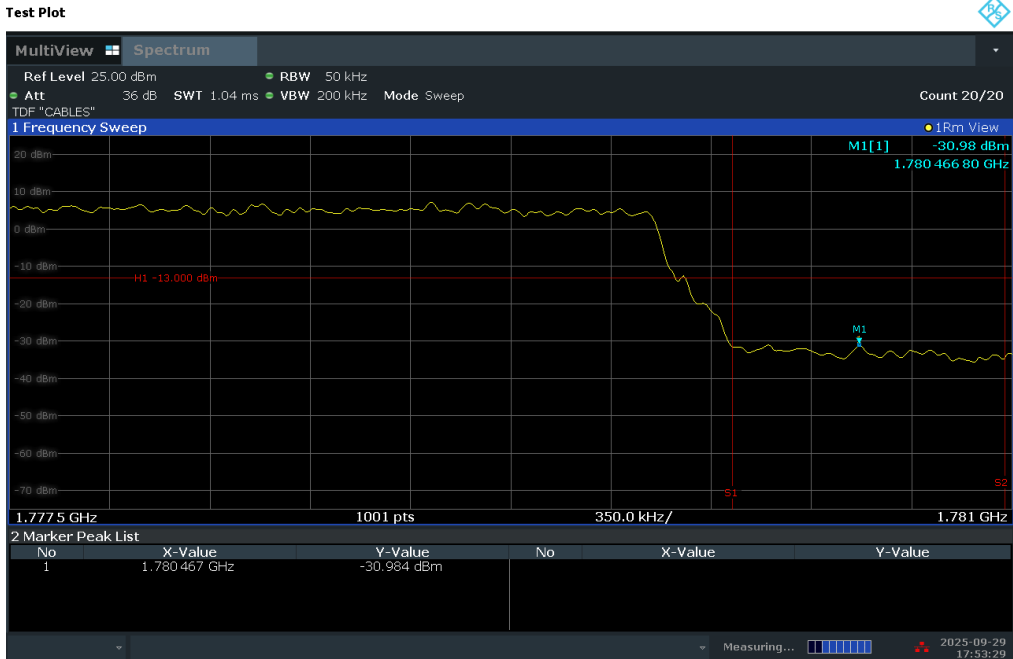
05:55:43 PM 09/29/2025

Plot 7-250. Lower Extended Band Edge Plot (LTE Band 66 – 5MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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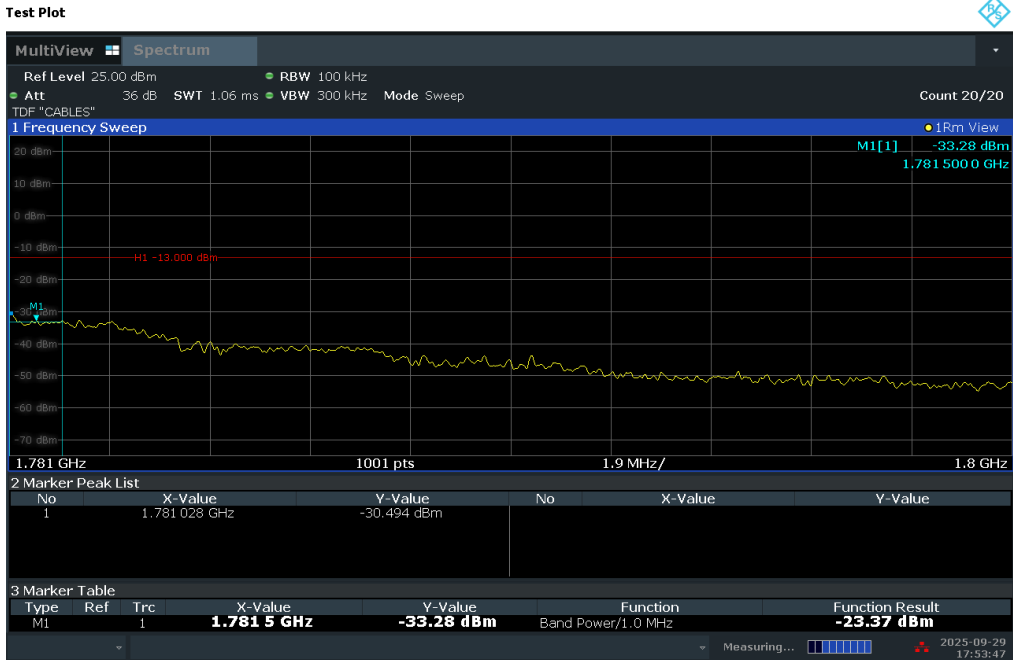
V2.2 09/07/2023

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05:53:30 PM 09/29/2025

Plot 7-251. Upper Band Edge Plot (LTE Band 66 – 5MHz QPSK – Full RB)



05:53:47 PM 09/29/2025

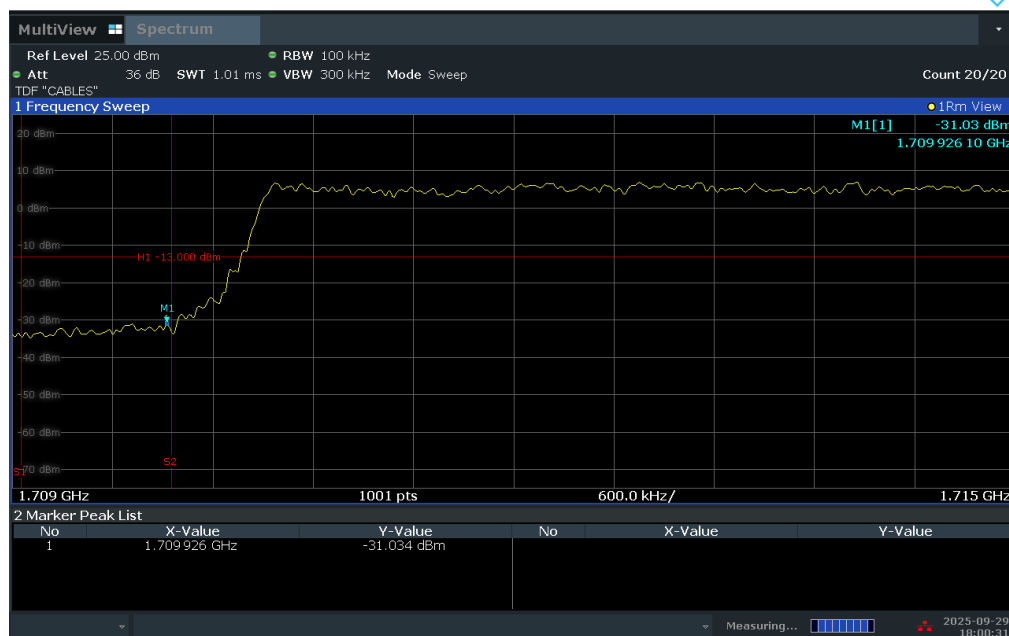
Plot 7-252. Upper Extended Band Edge Plot (LTE Band 66 – 5MHz QPSK – Full RB)

FCC ID: BCGA3460	element PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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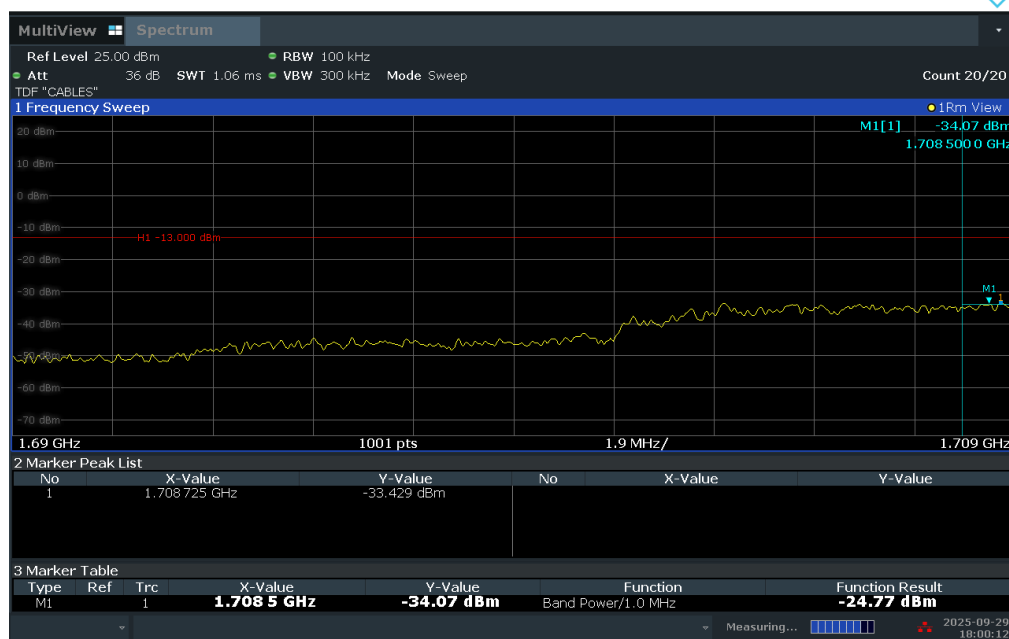
Test Plot



06:00:31 PM 09/29/2025

Plot 7-253. Lower Band Edge Plot (LTE Band 66 – 10MHz QPSK – Full RB)

Test Plot



06:00:13 PM 09/29/2025

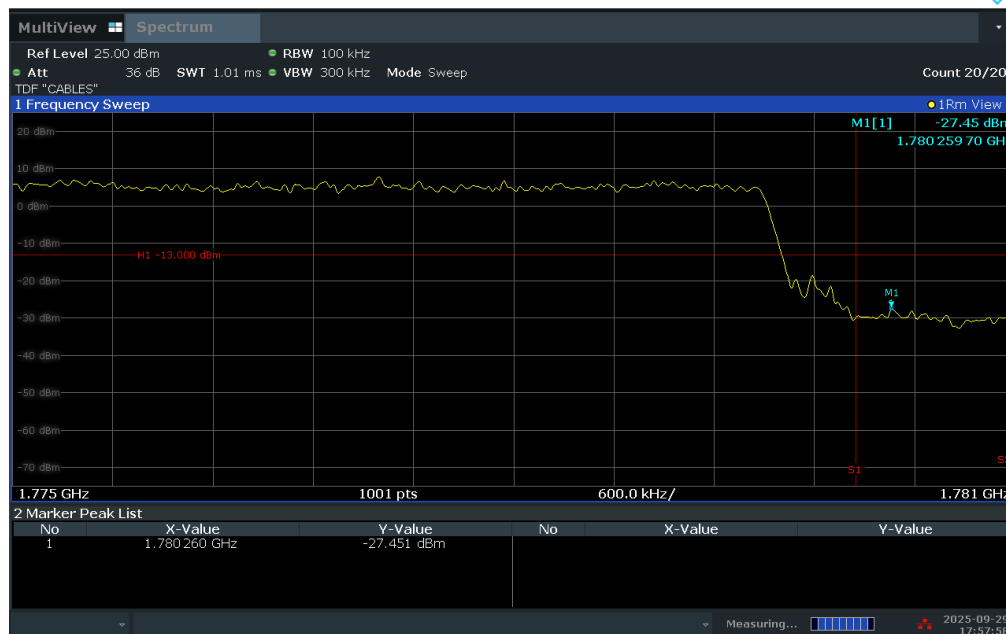
Plot 7-254. Lower Extended Band Edge Plot (LTE Band 66 – 10MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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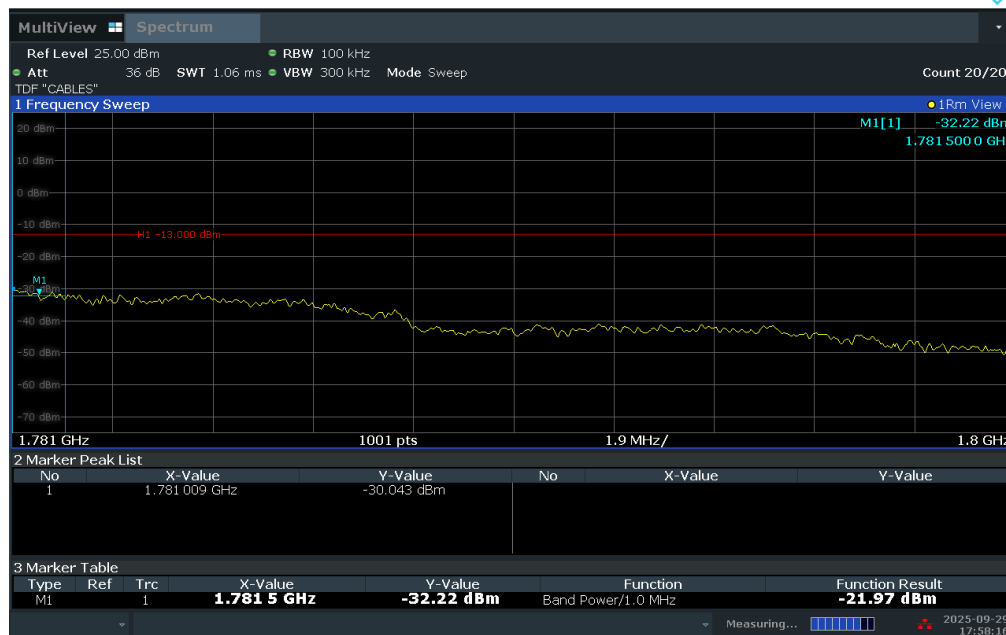
Test Plot



05:57:58 PM 09/29/2025

Plot 7-255. Upper Band Edge Plot (LTE Band 66 – 10MHz QPSK – Full RB)

Test Plot



05:58:16 PM 09/29/2025

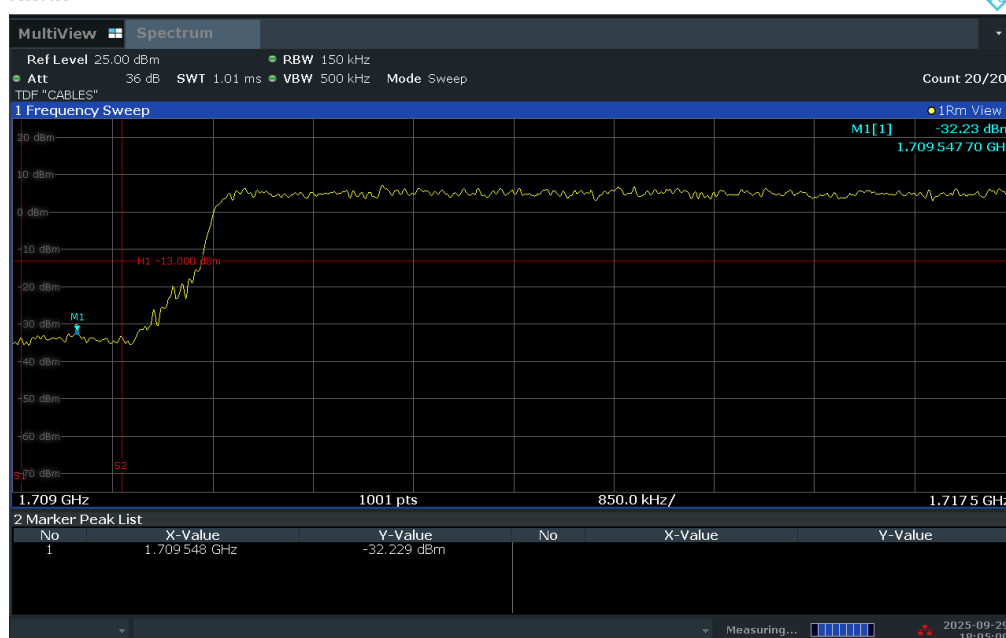
Plot 7-256. Upper Extended Band Edge Plot (LTE Band 66 – 10MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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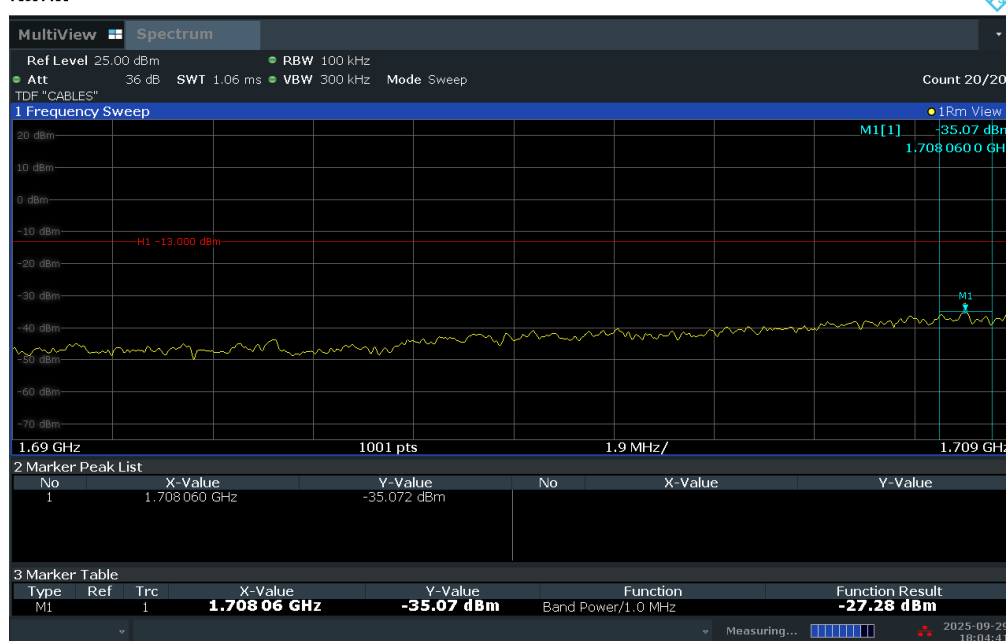
Test Plot



06:05:00 PM 09/29/2025

Plot 7-257. Lower Band Edge Plot (LTE Band 66 – 15MHz QPSK – Full RB)

Test Plot



06:04:42 PM 09/29/2025

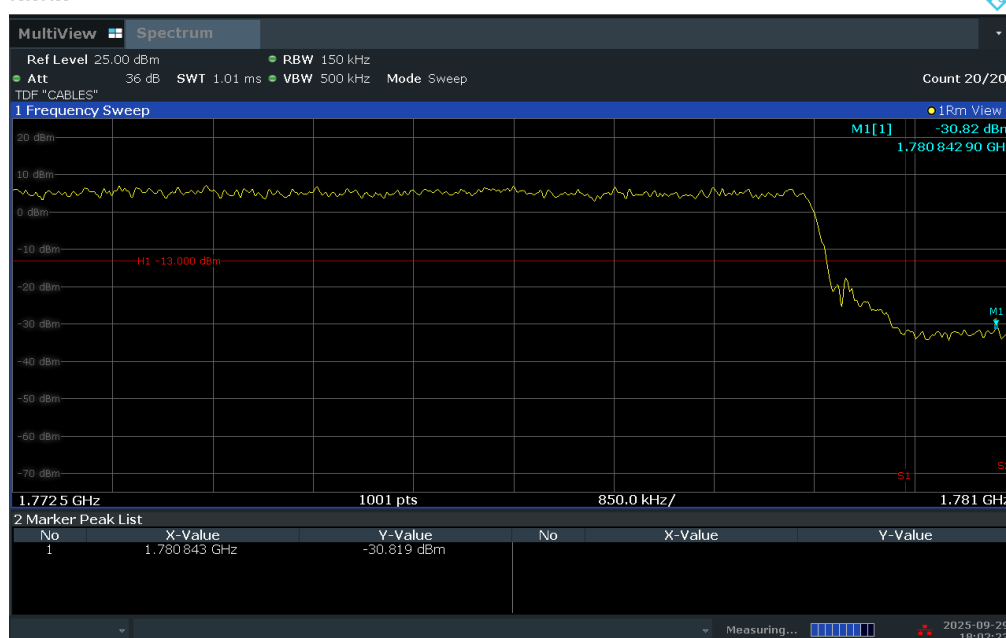
Plot 7-258. Lower Extended Band Edge Plot (LTE Band 66 – 15MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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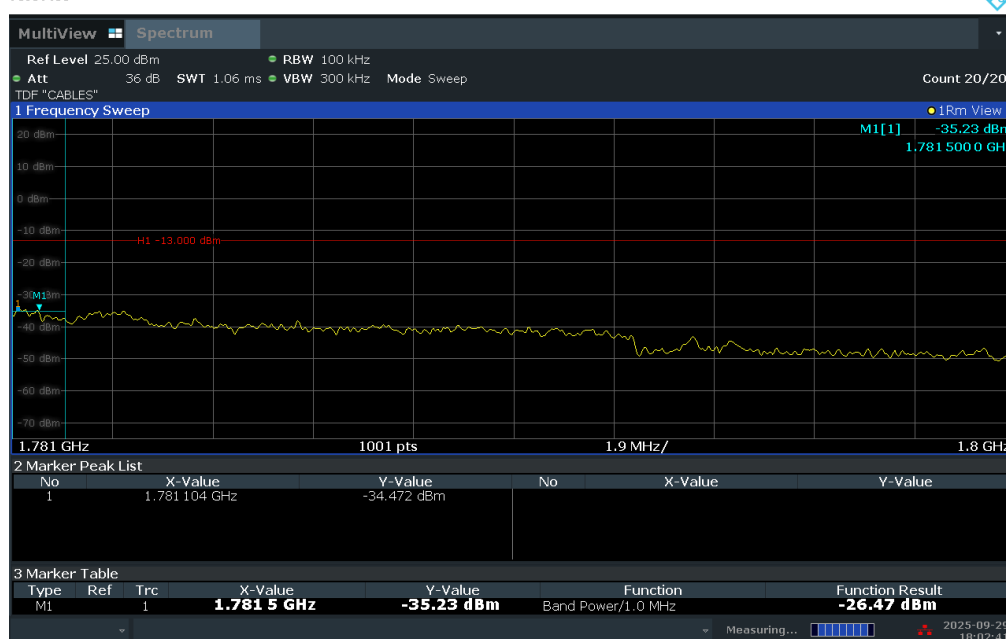
Test Plot



06:02:24 PM 09/29/2025

Plot 7-259. Upper Band Edge Plot (LTE Band 66 – 15MHz QPSK – Full RB)

Test Plot



06:02:42 PM 09/29/2025

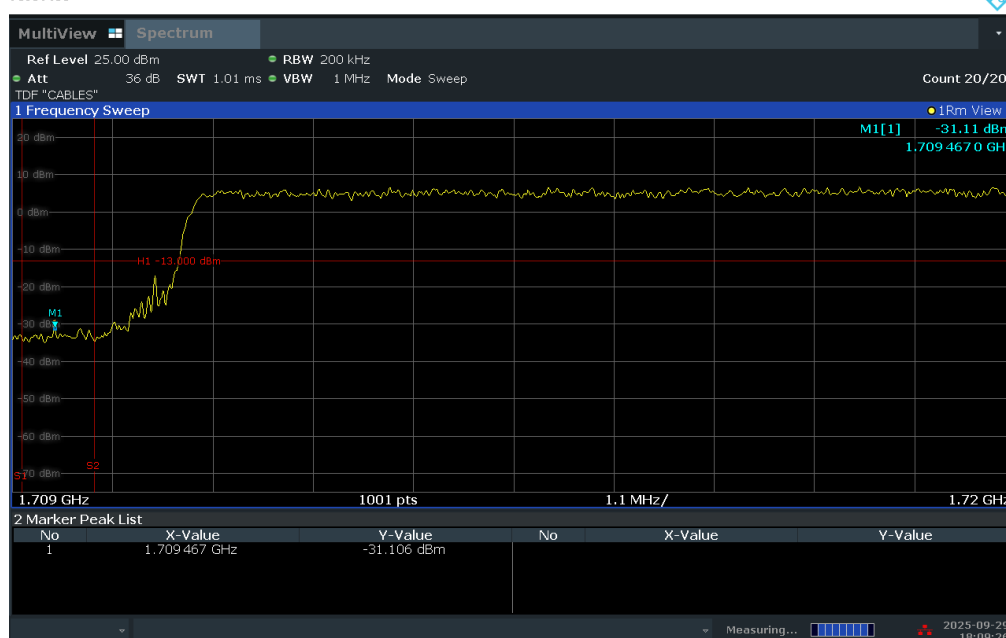
Plot 7-260. Upper Extended Band Edge Plot (LTE Band 66 – 15MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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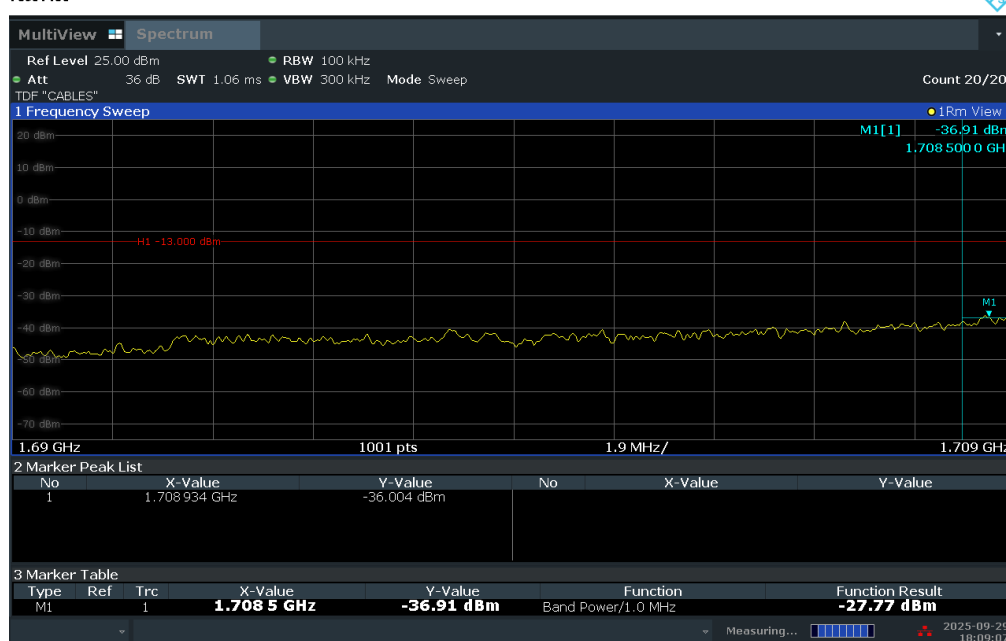
Test Plot



06:09:27 PM 09/29/2025

Plot 7-261. Lower Band Edge Plot (LTE Band 66 – 20MHz QPSK – Full RB)

Test Plot



06:09:08 PM 09/29/2025

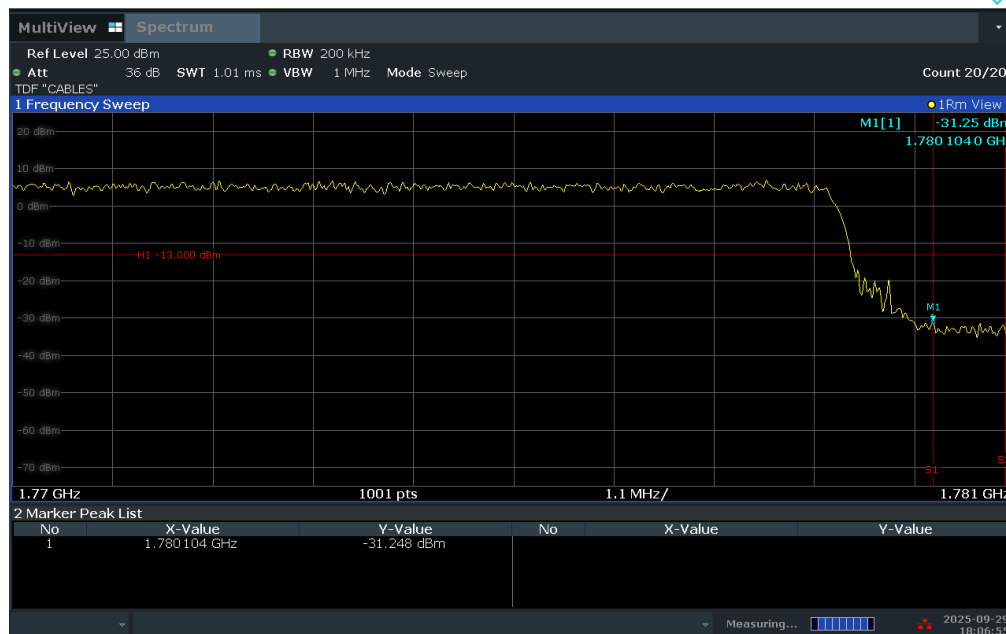
Plot 7-262. Lower Extended Band Edge Plot (LTE Band 66 – 20MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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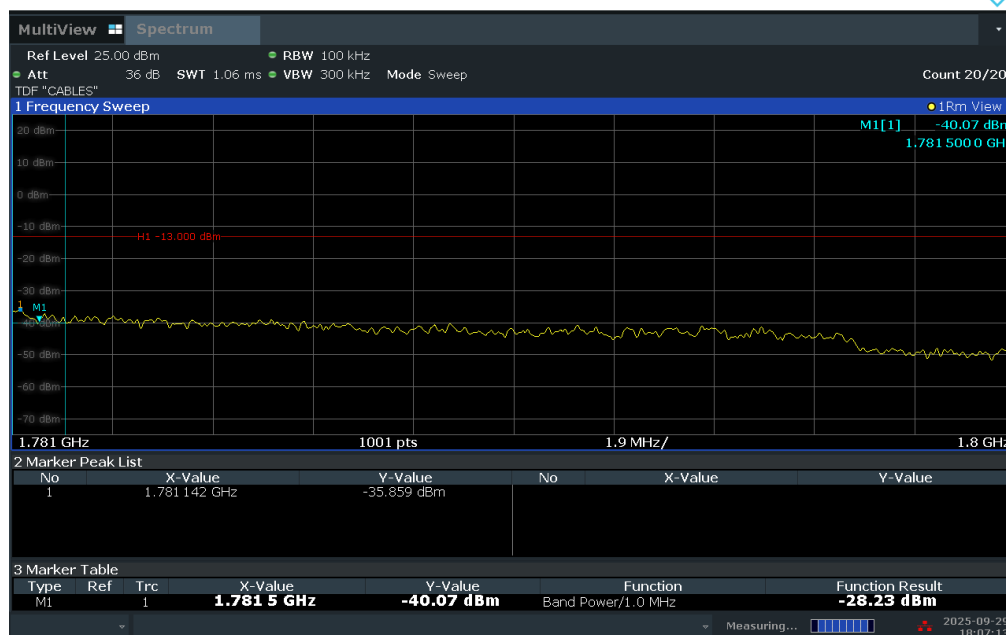
Test Plot



06:06:55 PM 09/29/2025

Plot 7-263. Upper Band Edge Plot (LTE Band 66 – 20MHz QPSK – Full RB)

Test Plot



06:07:14 PM 09/29/2025

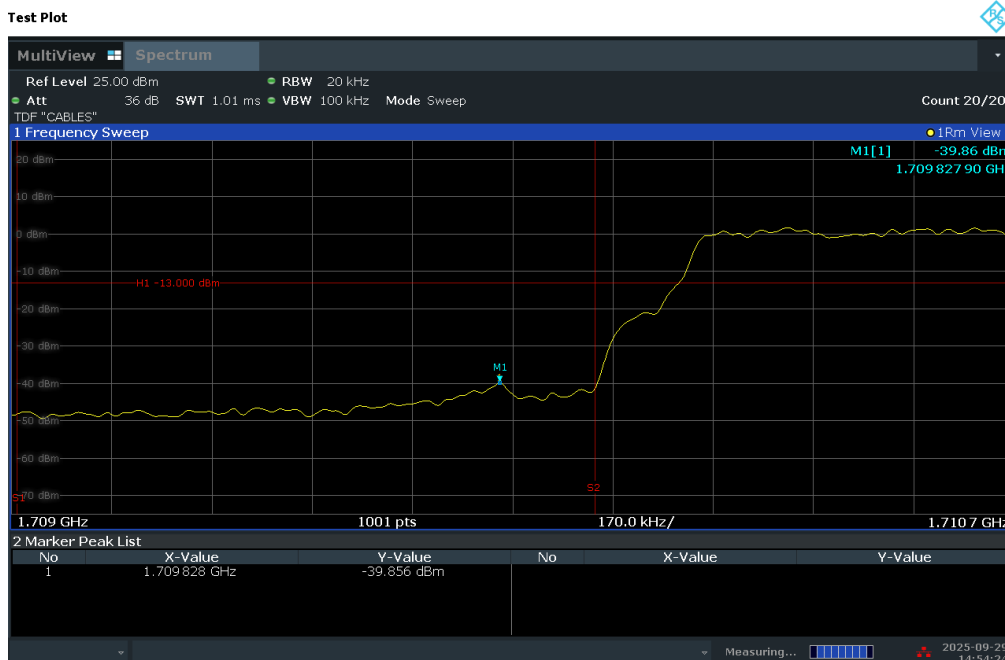
Plot 7-264. Upper Extended Band Edge Plot (LTE Band 66 – 20MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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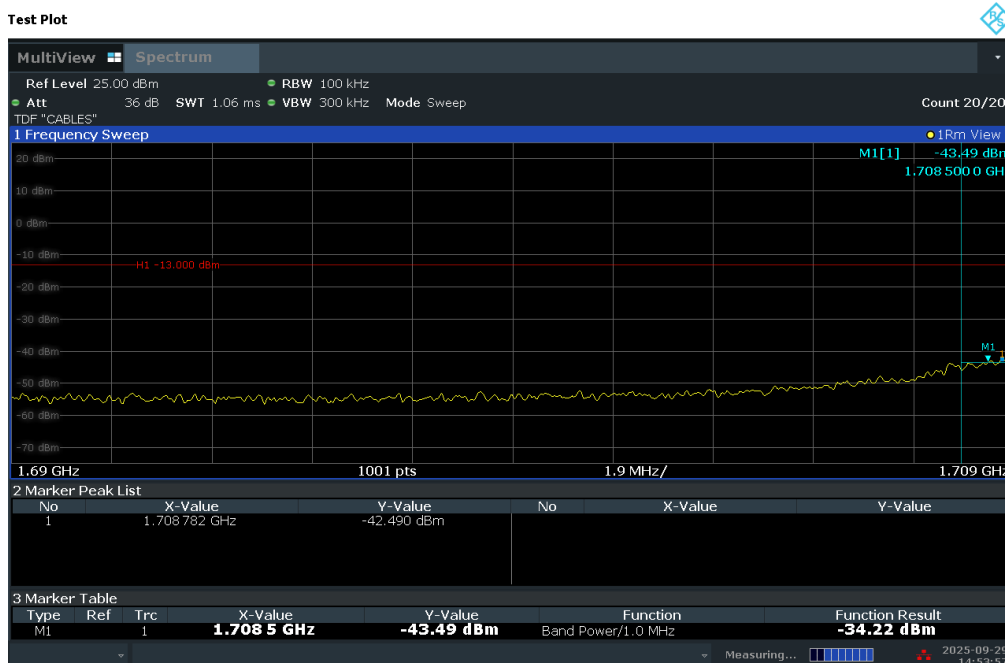
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LTE Band 4



02:54:25 PM 09/29/2025

Plot 7-265. Lower Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)



02:53:58 PM 09/29/2025

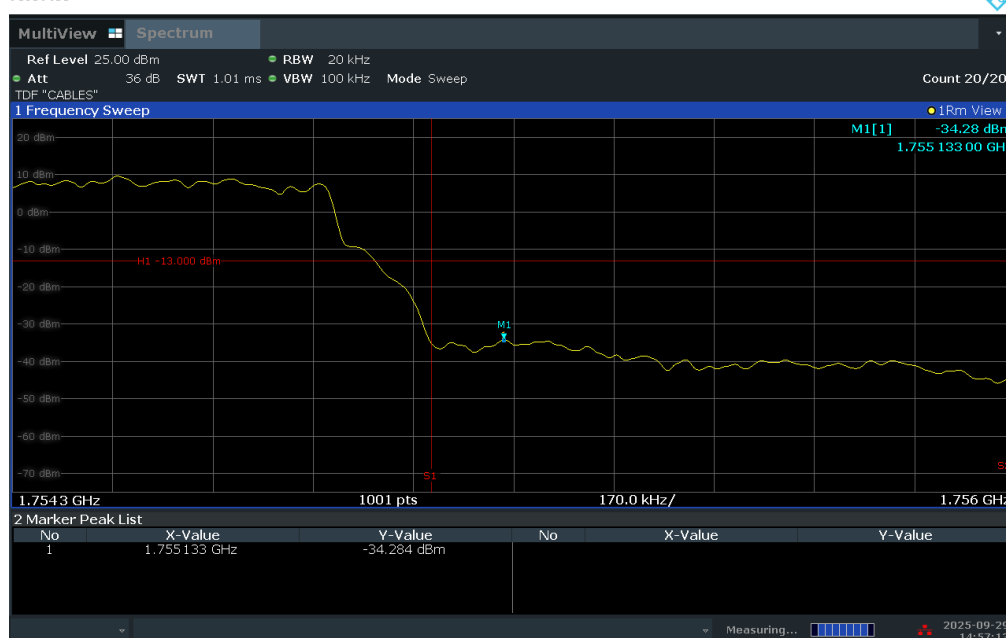
Plot 7-266. Lower Extended Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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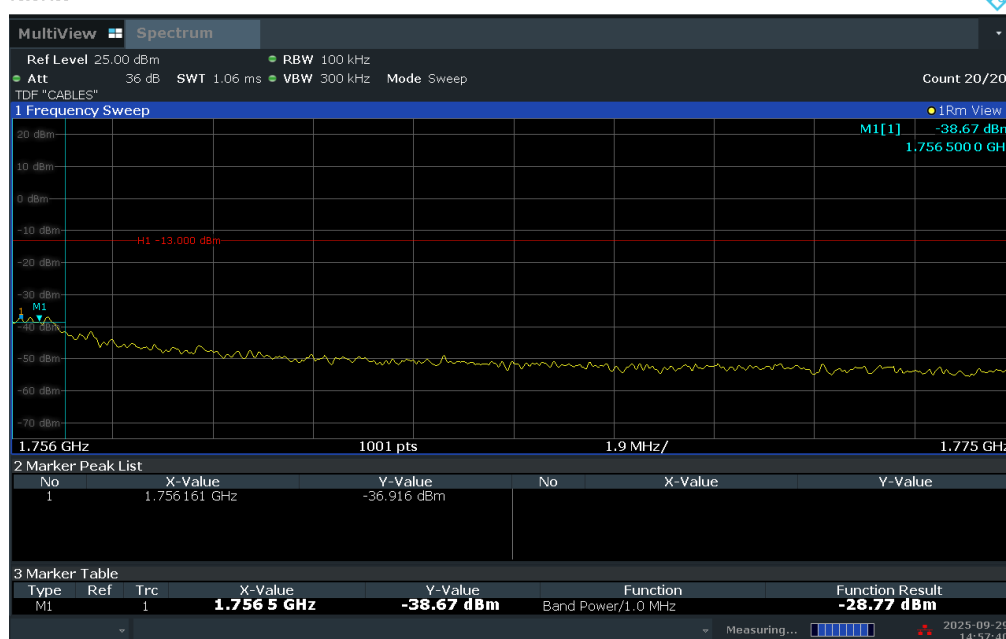
Test Plot



02:57:14 PM 09/29/2025

Plot 7-267. Upper Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)

Test Plot



02:57:41 PM 09/29/2025

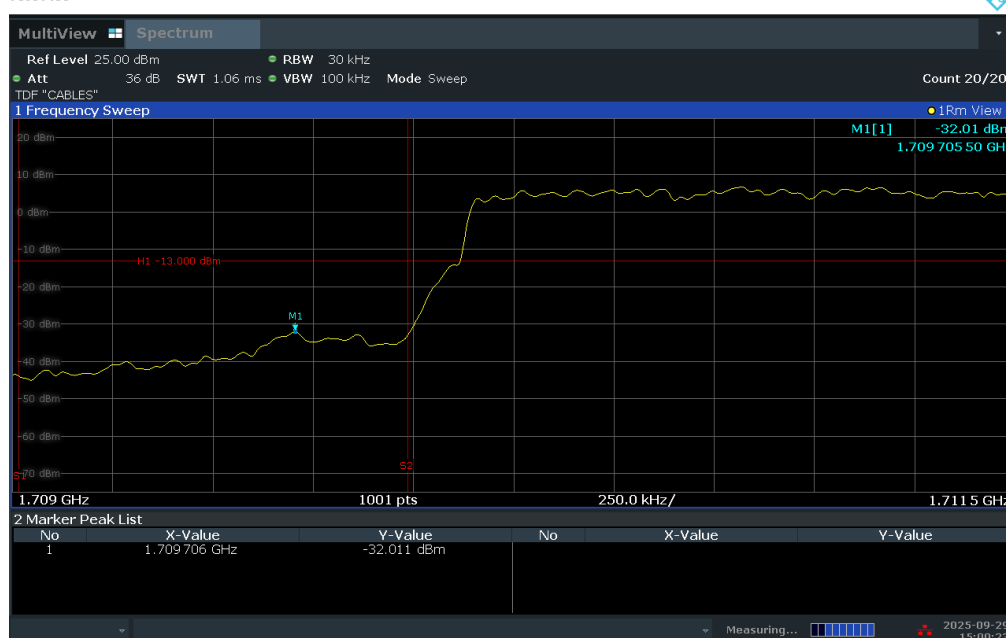
Plot 7-268. Upper Extended Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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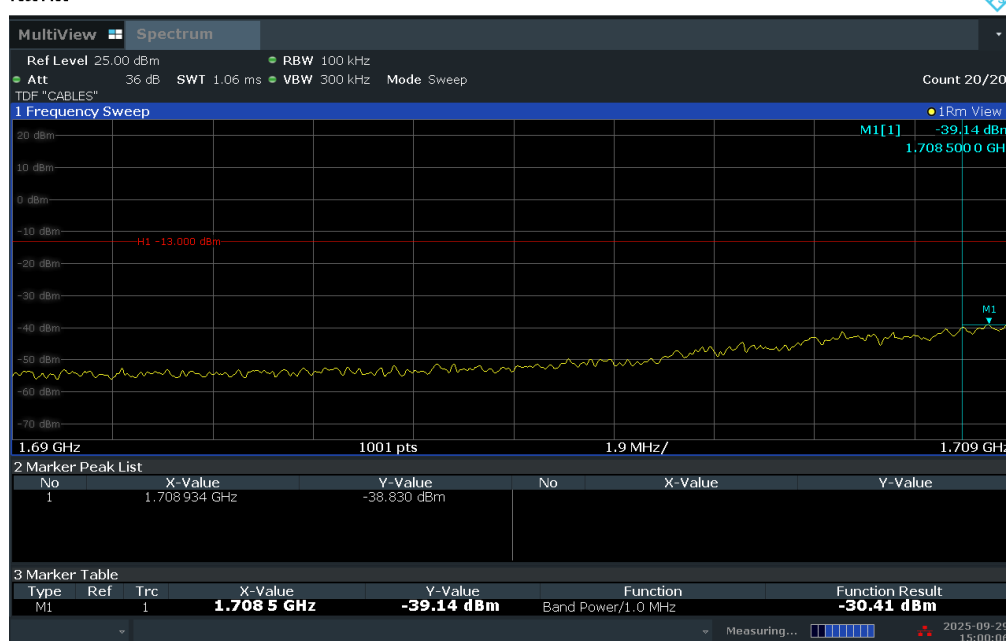
Test Plot



03:00:24 PM 09/29/2025

Plot 7-269. Lower Band Edge Plot (LTE Band 4 – 3MHz QPSK – Full RB)

Test Plot



03:00:07 PM 09/29/2025

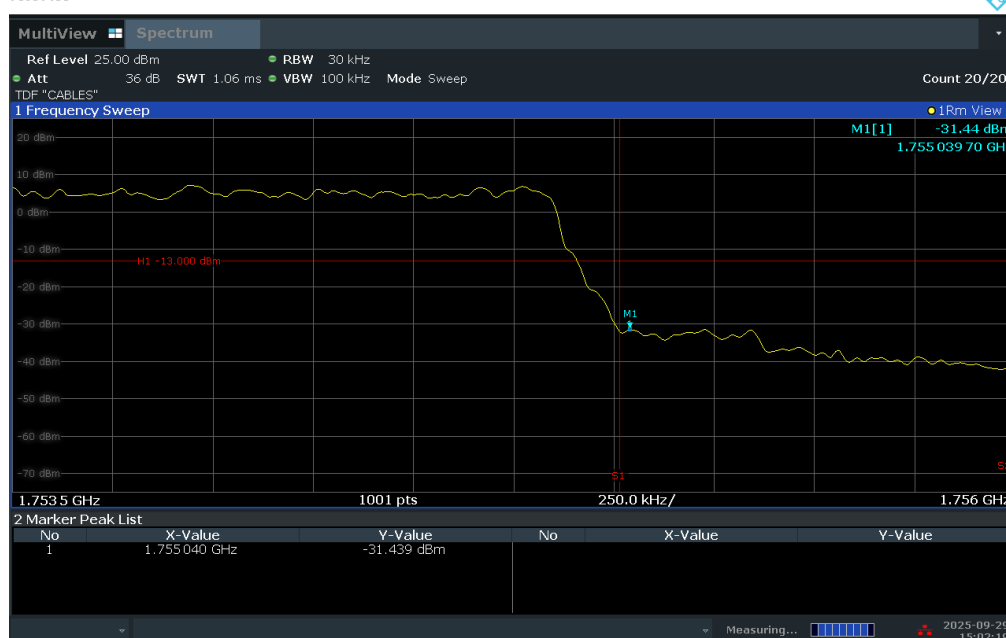
Plot 7-270. Lower Extended Band Edge Plot (LTE Band 4 – 3MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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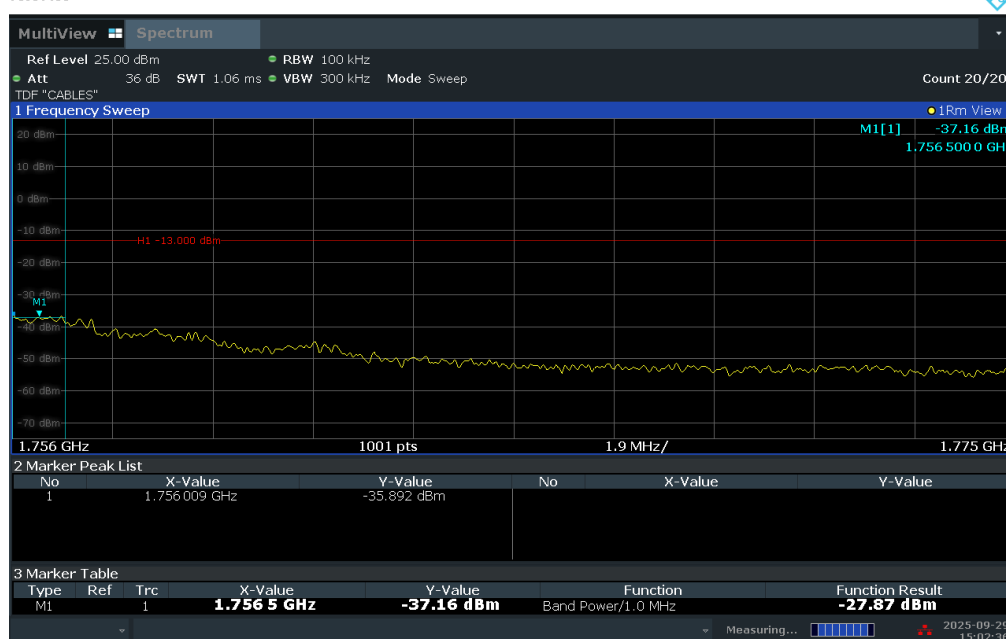
Test Plot



03:02:19 PM 09/29/2025

Plot 7-271. Upper Band Edge Plot (LTE Band 4 – 3MHz QPSK – Full RB)

Test Plot



03:02:37 PM 09/29/2025

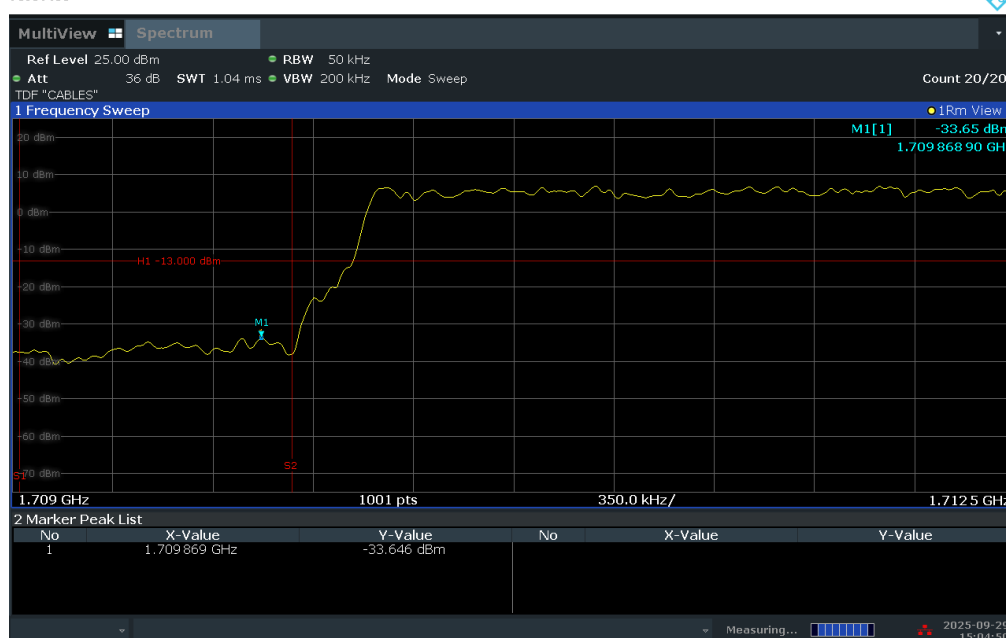
Plot 7-272. Upper Extended Band Edge Plot (LTE Band 4 – 3MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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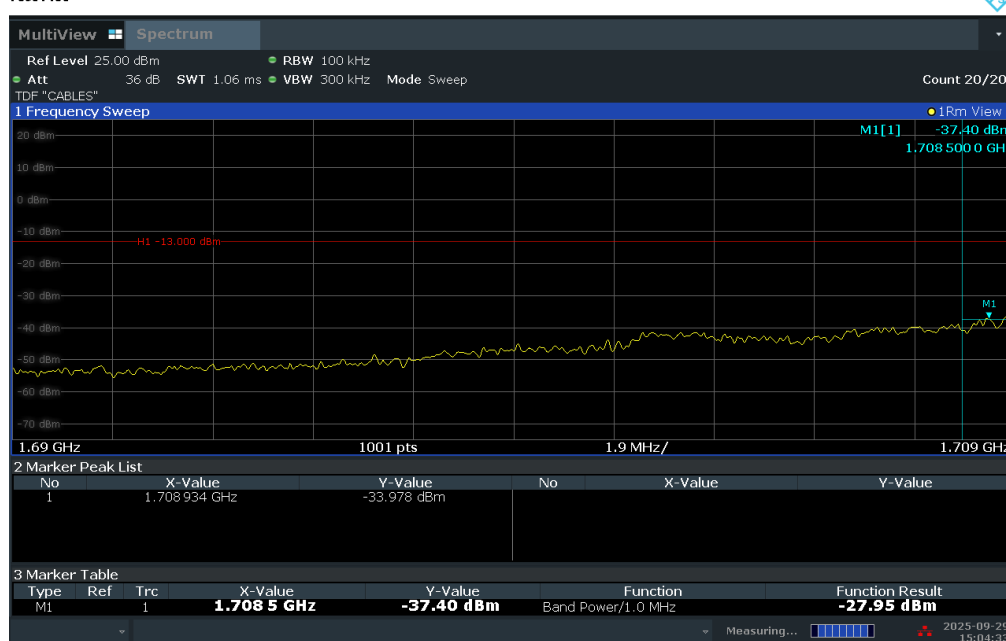
Test Plot



03:04:51 PM 09/29/2025

Plot 7-273. Lower Band Edge Plot (LTE Band 4 – 5MHz QPSK – Full RB)

Test Plot



03:04:33 PM 09/29/2025

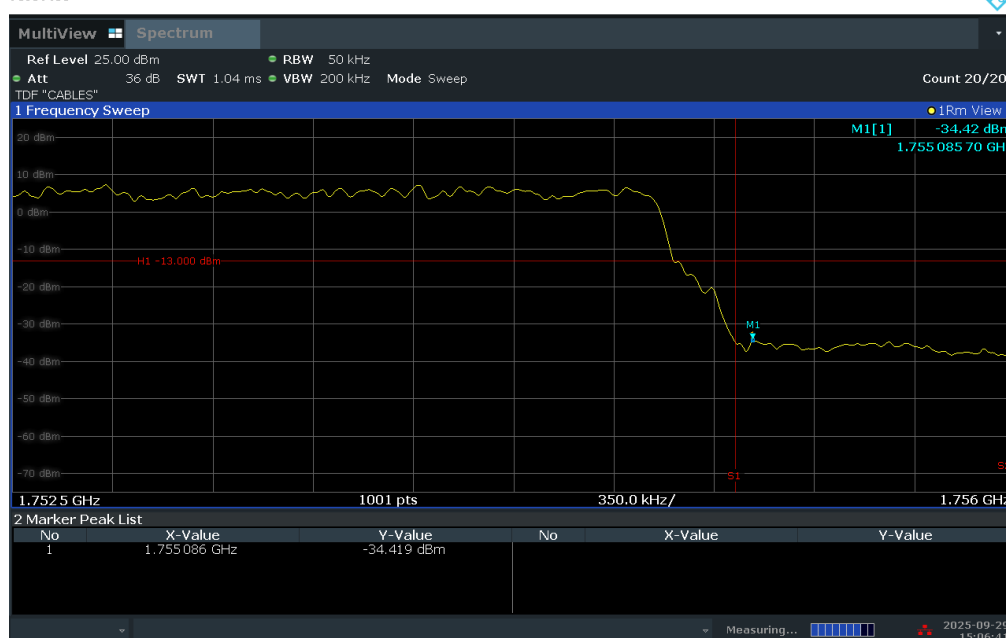
Plot 7-274. Lower Extended Band Edge Plot (LTE Band 4 – 5MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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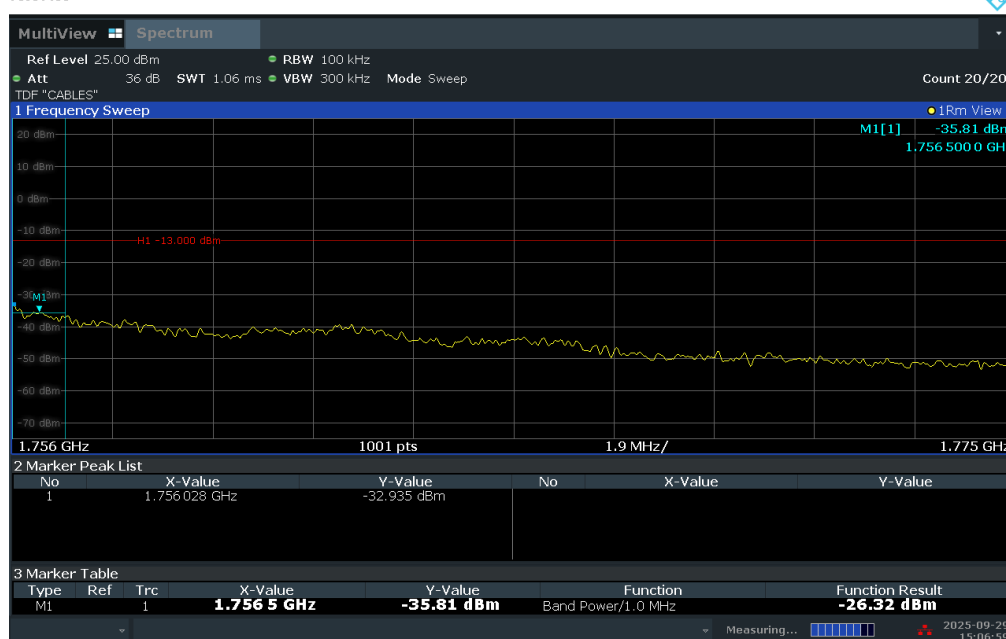
Test Plot



03:06:41 PM 09/29/2025

Plot 7-275. Upper Band Edge Plot (LTE Band 4 – 5MHz QPSK – Full RB)

Test Plot



03:06:59 PM 09/29/2025

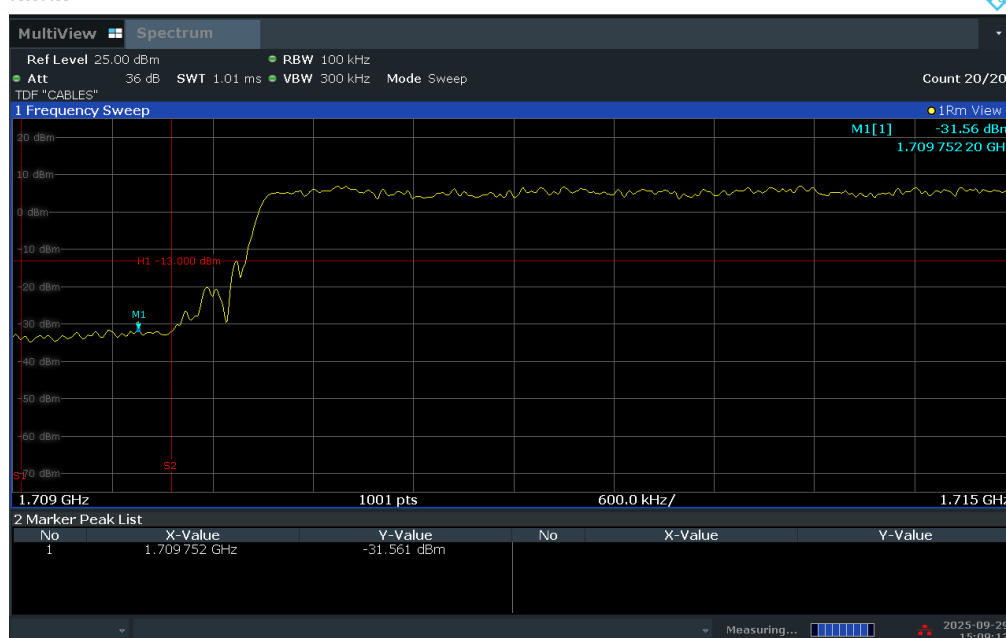
Plot 7-276. Upper Extended Band Edge Plot (LTE Band 4 – 5MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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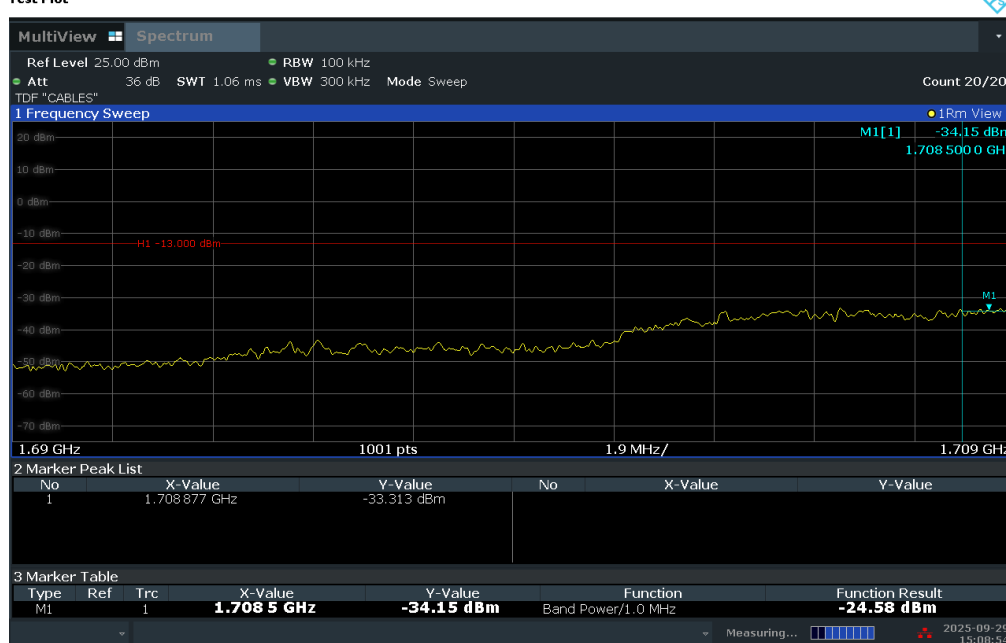
Test Plot



03:09:13 PM 09/29/2025

Plot 7-277. Lower Band Edge Plot (LTE Band 4 – 10MHz QPSK – Full RB)

Test Plot



03:08:55 PM 09/29/2025

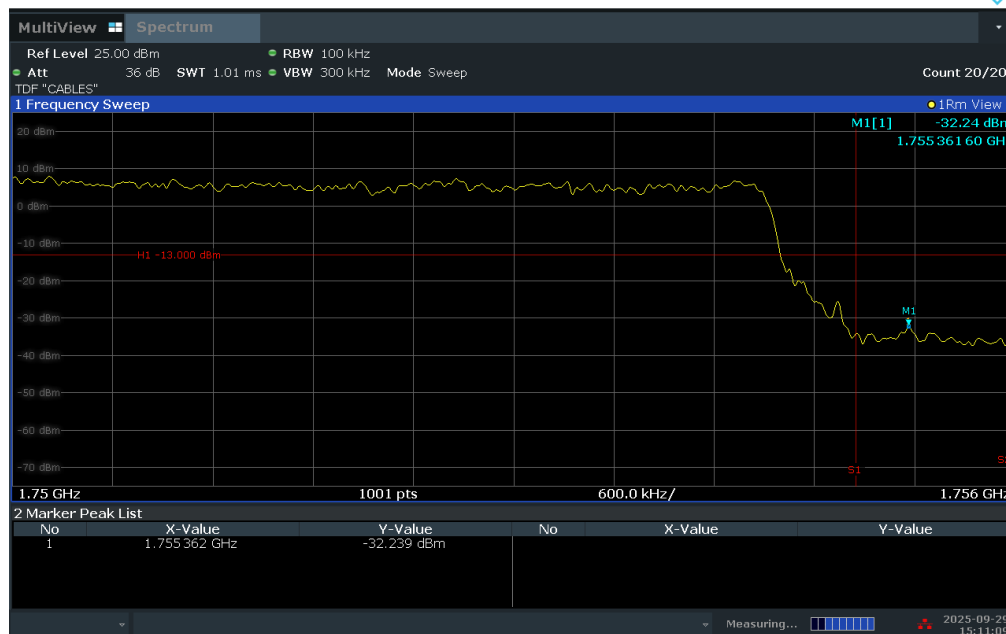
Plot 7-278. Lower Extended Band Edge Plot (LTE Band 4 – 10MHz QPSK – Full RB)

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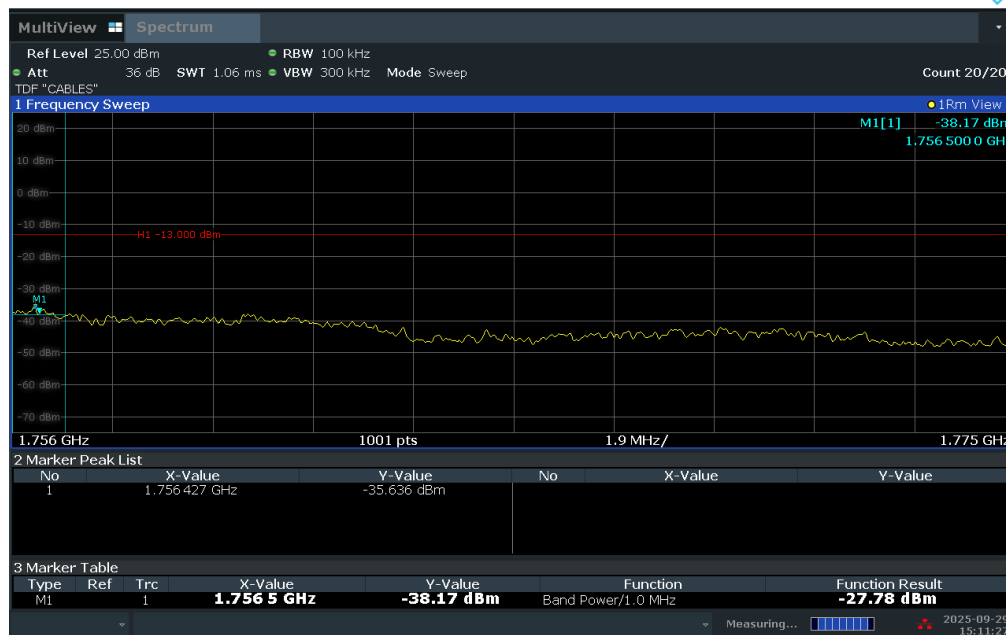
Test Plot



03:11:09 PM 09/29/2025

Plot 7-279. Upper Band Edge Plot (LTE Band 4 – 10MHz QPSK – Full RB)

Test Plot



03:11:27 PM 09/29/2025

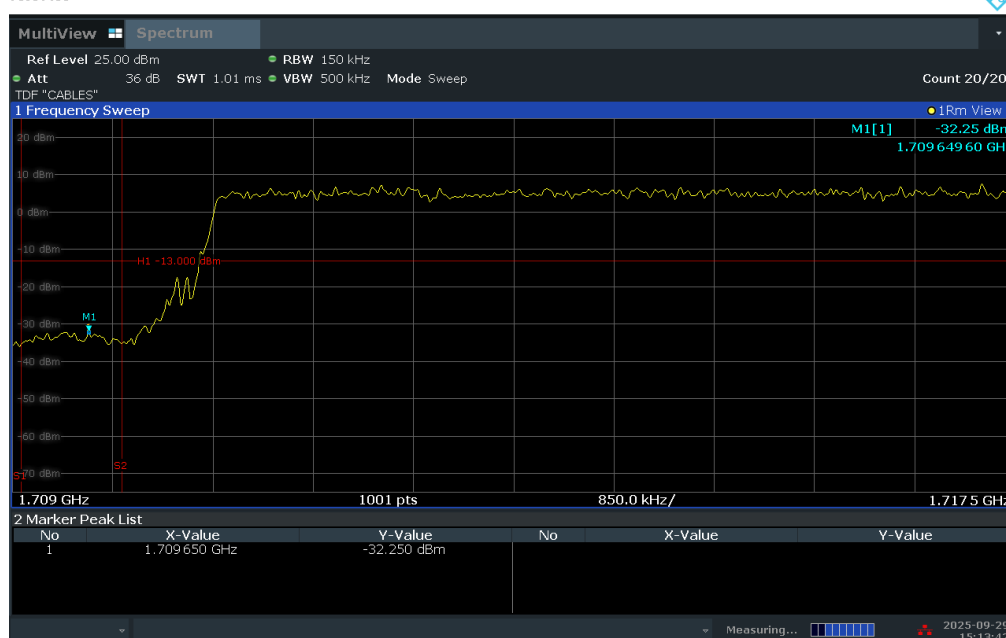
Plot 7-280. Upper Extended Band Edge Plot (LTE Band 4 – 10MHz QPSK – Full RB)

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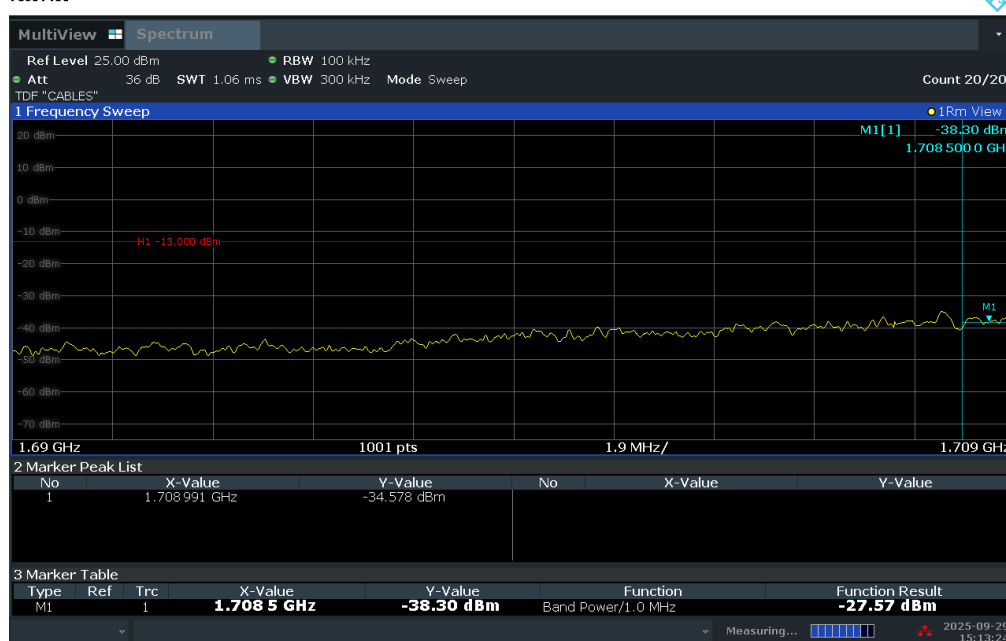
Test Plot



03:13:43 PM 09/29/2025

Plot 7-281. Lower Band Edge Plot (LTE Band 4 – 15MHz QPSK – Full RB)

Test Plot



03:13:25 PM 09/29/2025

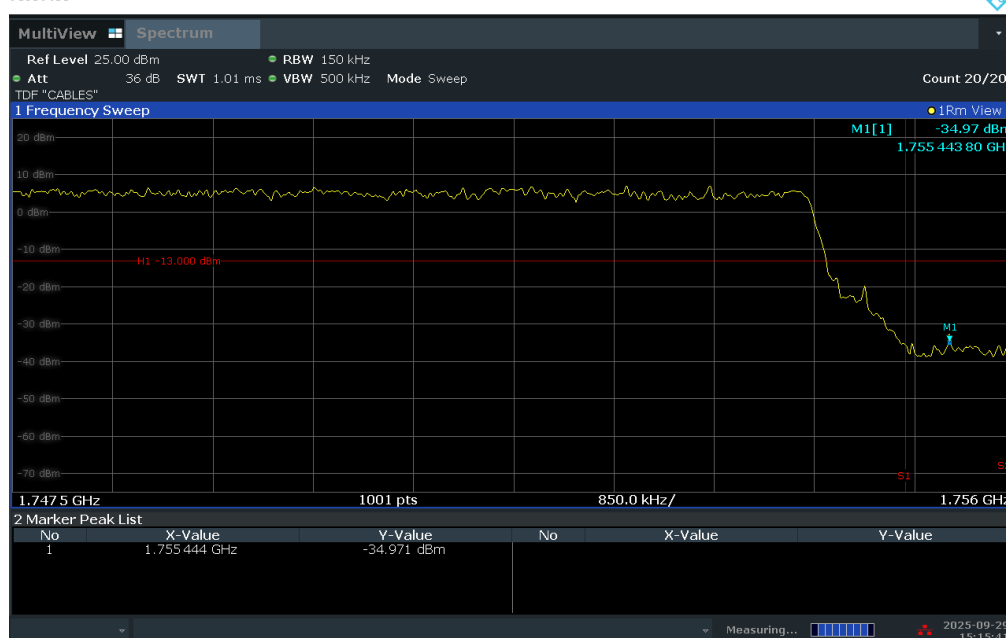
Plot 7-282. Lower Extended Band Edge Plot (LTE Band 4 – 15MHz QPSK – Full RB)

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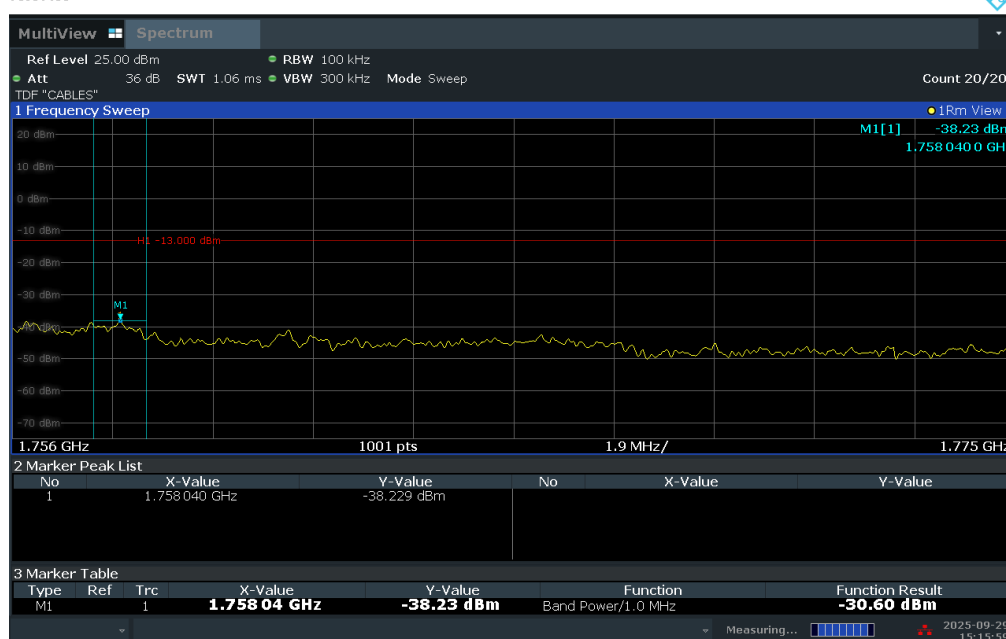
Test Plot



03:15:41 PM 09/29/2025

Plot 7-283. Upper Band Edge Plot (LTE Band 4 – 15MHz QPSK – Full RB)

Test Plot



03:16:00 PM 09/29/2025

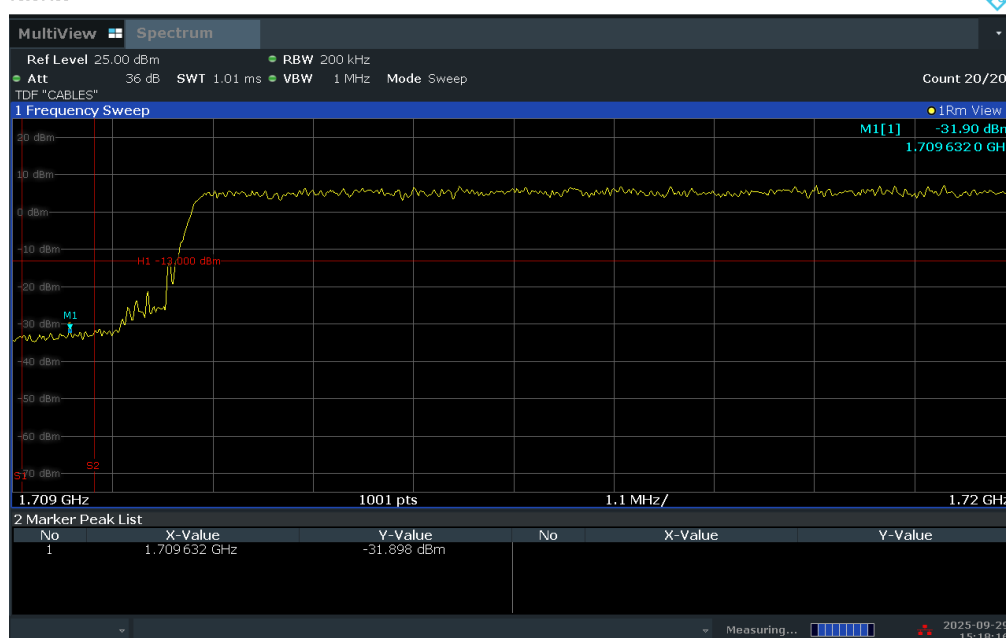
Plot 7-284. Upper Extended Band Edge Plot (LTE Band 4 – 15MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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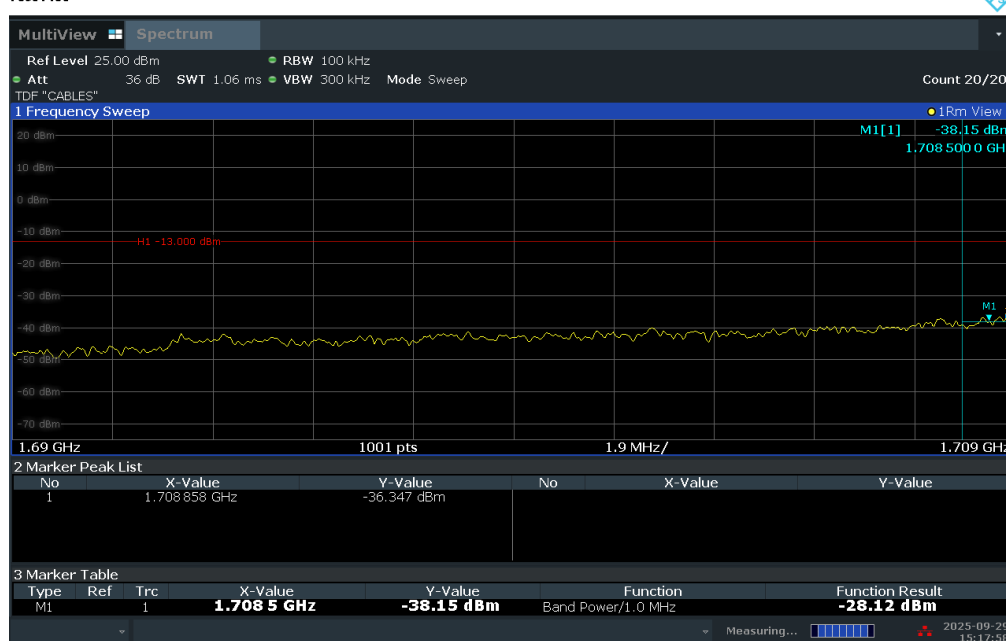
Test Plot



03:18:17 PM 09/29/2025

Plot 7-285. Lower Band Edge Plot (LTE Band 4 – 20MHz QPSK – Full RB)

Test Plot



03:17:58 PM 09/29/2025

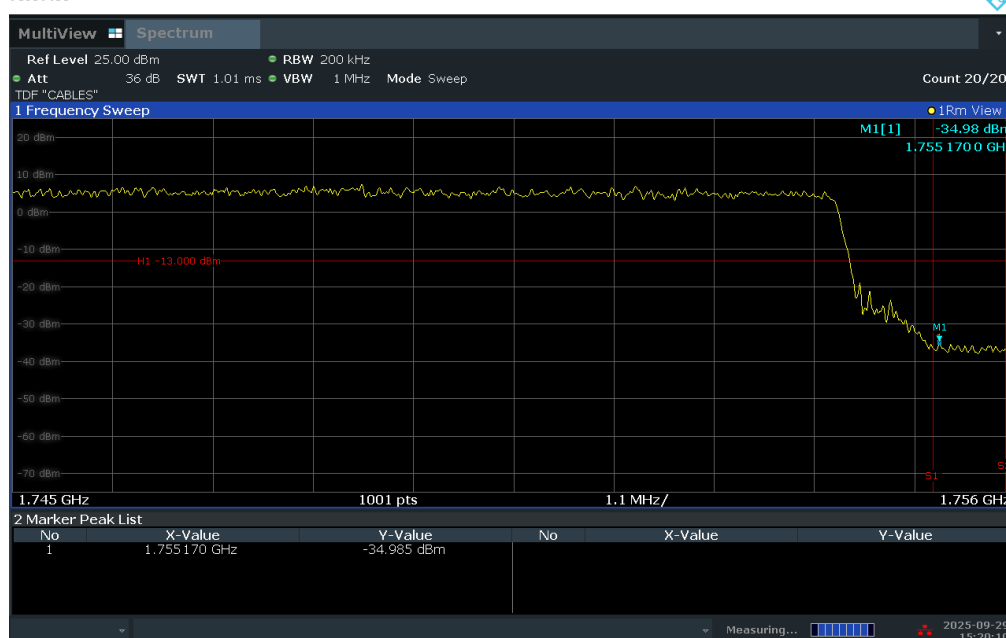
Plot 7-286. Lower Extended Band Edge Plot (LTE Band 4 – 20MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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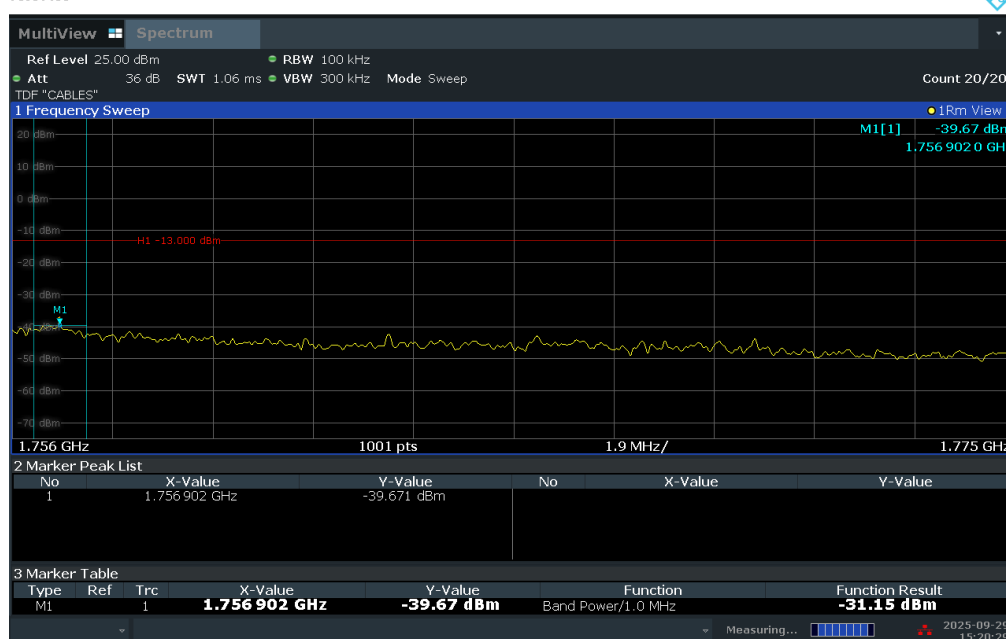
Test Plot



03:20:11 PM 09/29/2025

Plot 7-287. Upper Band Edge Plot (LTE Band 4 – 20MHz QPSK – Full RB)

Test Plot



03:20:29 PM 09/29/2025

Plot 7-288. Upper Extended Band Edge Plot (LTE Band 4 – 20MHz QPSK – Full RB)

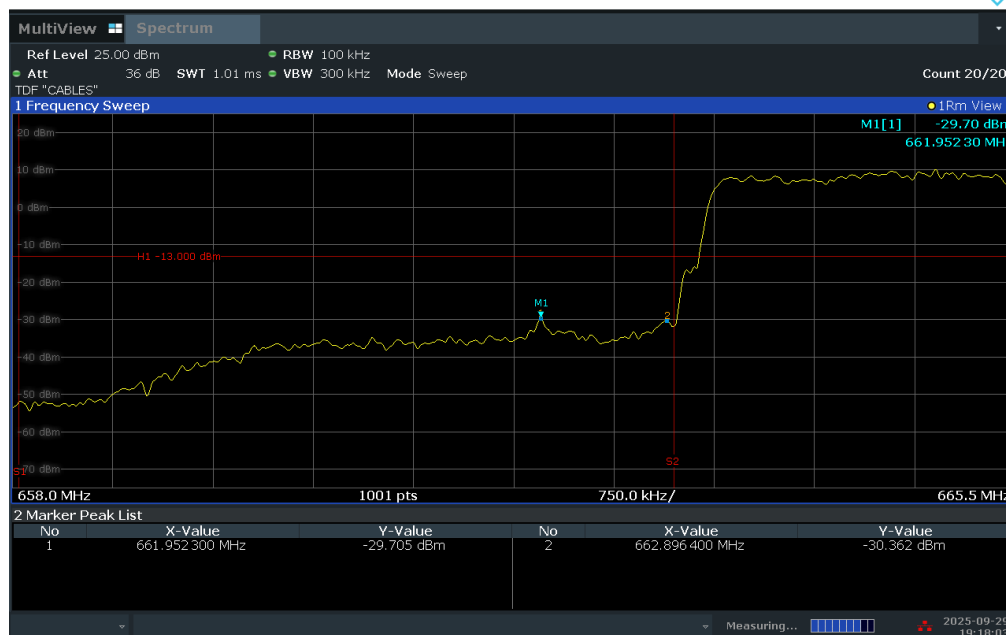
FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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LTE Band 71

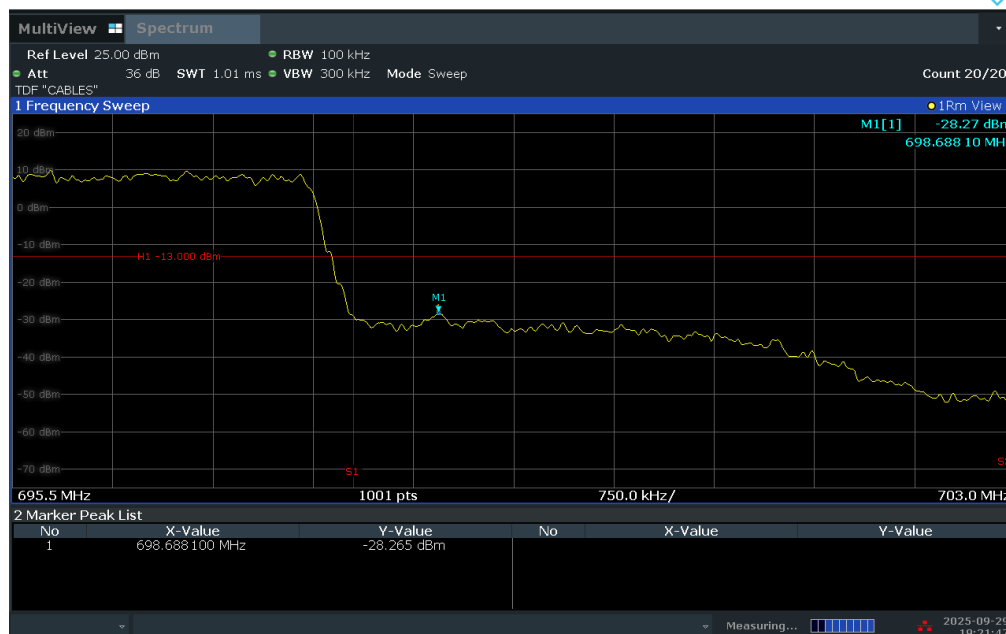
Test Plot



07:18:04 PM 09/29/2025

Plot 7-289. Lower Band Edge Plot (LTE Band 71 - 5MHz QPSK – Full RB)

Test Plot



07:21:48 PM 09/29/2025

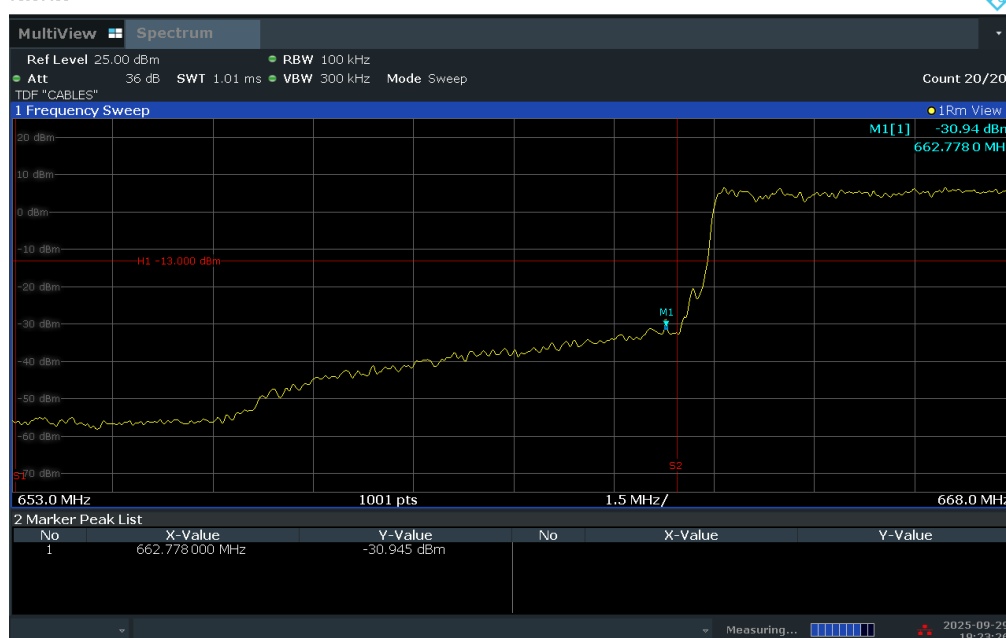
Plot 7-290. Upper Band Edge Plot (LTE Band 71 - 5MHz QPSK – Full RB)

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Test Plot



07:23:26 PM 09/29/2025

Plot 7-291. Lower Band Edge Plot (LTE Band 71 - 10MHz QPSK – Full RB)

Test Plot



07:25:01 PM 09/29/2025

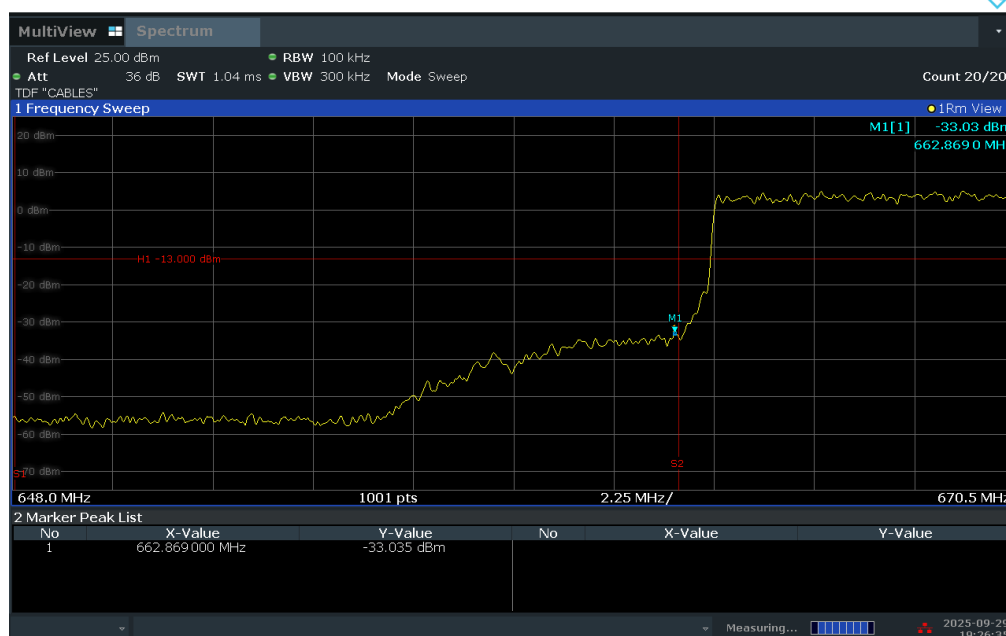
Plot 7-292. Upper Band Edge Plot (LTE Band 71 - 10MHz QPSK – Full RB)

FCC ID: BCGA3460	 PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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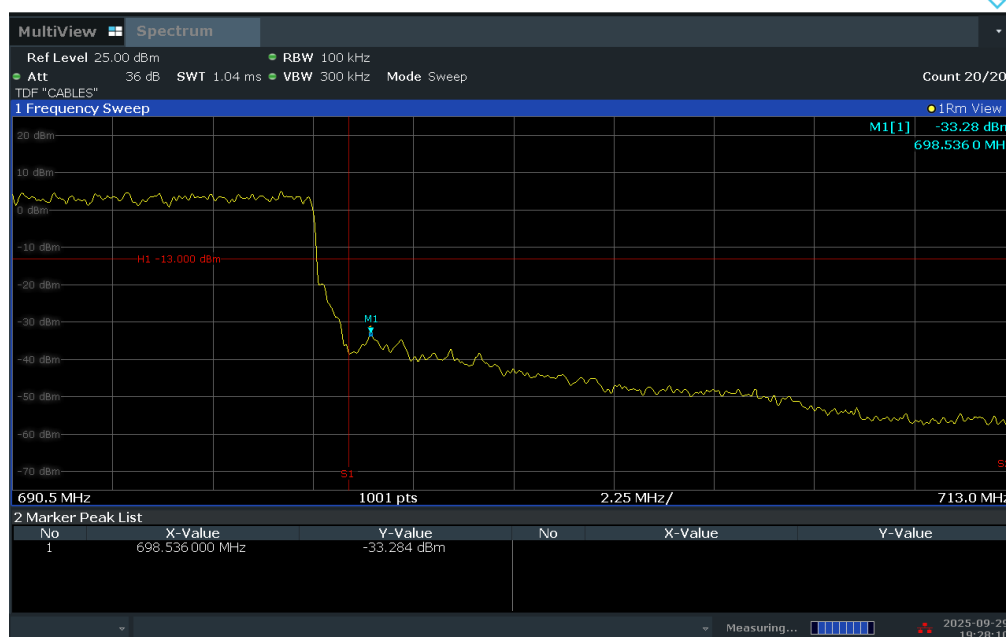
Test Plot



07:26:36 PM 09/29/2025

Plot 7-293. Lower Band Edge Plot (LTE Band 71 - 15MHz QPSK – Full RB)

Test Plot



07:28:11 PM 09/29/2025

Plot 7-294. Upper Band Edge Plot (LTE Band 71 - 15MHz QPSK – Full RB)

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